TEST REPORT

FCC Sub6 n26(Part90) Test for SM-F741U
Certification

APPLICANT
SAMSUNG Electronics Co., Ltd.

REPORT NO.
HCT-RF-2404-FC029-R1

DATE OF ISSUE
May 3, 2024

Tested by
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BongJai Huh / CEO

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TEST REPORT

REPORT NO.
HCT-RF-2404-FC029-R1

DATE OF ISSUE
May 03, 2024

Additional Model
SM-F741U1

Applicant	**SAMSUNG Electronics Co., Ltd.** 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Rep. of Korea
Product Name Model Name	Mobile Phone SM-F741U
Date of Test	February 27, 2024 ~ April 19, 2024
FCC ID	A3LSMF741U
Location of Test	■ Permanent Testing Lab ☐ On Site Testing (Address: 74, Seoicheon-ro 578beon-gil, Majang-myeon, Icheon-si, Gyeonggi-do, 17383 Republic of Korea)
FCC Classification:	PCS Licensed Transmitter Held to Ear (PCE)
FCC Rule Part(s):	§ 90, § 22

REVISION HISTORY

The revision history for this test report is shown in table.

Revision No.	Date of Issue	Description
0	April 26, 2024	Initial Release
1	May 03, 2024	Revised the date of test (Page 2.)

Notice

Content
The measurements shown in this report were made in accordance with the procedures specified in CFR47 section § 2.947. I assume full responsibility for the accuracy and completeness of these measurements, and for the qualifications of all persons taking them. HCT CO., LTD. Certifies that no party to this application has subject to a denial of Federal benefits that includes FCC benefits pursuant to section 5301 of the Anti-Drug Abuse Act of 1998,21 U.S. C.853(a)
The results shown in this test report only apply to the sample(s), as received, provided by the applicant, unless otherwise stated. The test results have only been applied with the test methods required by the standard(s).
When confirmation of authenticity of this test report is required, please contact www.hct.co.kr
The test results in this test report are not associated with the ((KS Q) ISO/IEC 17025) accreditation by KOLAS (Korea Laboratory Accreditation Scheme) / A2LA (American Association for Laboratory Accreditation) that are under the ILAC (International Laboratory Accreditation Cooperation) Mutual Recognition Agreement (MRA).

CONTENTS

MEASUREMENT REPORT

1. GENERAL INFORMATION

Applicant Name:	SAMSUNG Electronics Co., Ltd.
Address:	129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Rep. of Korea
FCC ID:	A3LSMF741U
Application Type:	Certification
FCC Classification:	PCS Licensed Transmitter Held to Ear (PCE)
FCC Rule Part(s):	§ 90, § 22
EUT Type:	Mobile phone
Model(s):	SM-F741U
Additional Model(s)	SM-F741U1
SCS(kHz):	15
Bandwidth(MHz):	5, 10, 15, 20
Waveform:	CP-OFDM, DFT-S-OFDM
Modulation:	DFT-S-OFDM: PI/2 BPSK, QPSK, 16QAM, 64QAM, 256QAM CP-OFDM: QPSK, 16QAM, 64QAM, 256QAM
Tx Frequency:	816.5 MHz – 824.0 MHz (Sub6 n26 (5 MHz)) 819.0 MHz – 824.0 MHz (Sub6 n26 (10 MHz)) 821.5 MHz – 824.0 MHz (Sub6 n26 (15 MHz)) 824.0 MHz (Sub6 n26 (20 MHz))
Date(s) of Tests:	February 27, 2024 ~ April 19, 2024
Serial number:	Radiated : R3CX20KJSJW Conducted : 7B5599BDA3507ECE

1.1. MAXIMUM OUTPUT POWER

Mode (MHz)	Tx Frequency (MHz)	Emission Designator	Modulation	Conducted Output Power	
				Max. Power (W)	Max. Power (dBm)
Sub6 n26 (5)	816.5 – 824.0	4M47G7D	PI/2 BPSK	0.256	24.09
		4M53G7D	QPSK	0.264	24.21
		4M50W7D	16QAM	0.200	23.02
		4M51W7D	64QAM	0.137	21.38
		4M50W7D	256QAM	0.098	19.90
Sub6 n26 (10)	819.0 – 824.0	8M95G7D	PI/2 BPSK	0.256	24.09
		9M01G7D	QPSK	0.267	24.27
		8M97W7D	16QAM	0.208	23.18
		8M98W7D	64QAM	0.140	21.46
		8M95W7D	256QAM	0.088	19.45
Sub6 n26 (15)	821.5 – 824.0	13M5G7D	PI/2 BPSK	0.259	24.13
		13M5G7D	QPSK	0.253	24.03
		13M4W7D	16QAM	0.199	22.98
		13M5W7D	64QAM	0.144	21.59
		13M5W7D	256QAM	0.092	19.63
Sub6 n26 (20)	824.0	17M9G7D	PI/2 BPSK	0.245	23.89
		18M0G7D	QPSK	0.251	24.00
		17M9W7D	16QAM	0.204	23.09
		17M9W7D	64QAM	0.146	21.64
		17M9W7D	256QAM	0.085	19.28

2. INTRODUCTION

2.1. DESCRIPTION OF EUT

The EUT was a Mobile Phone with GSM/GPRS/EGPRS/UMTS and LTE, Sub 6, mmWave.
It also supports IEEE 802.11 a/b/g/n/ac/ax (20/40/80/160 MHz), Bluetooth(iPA, ePA), BT LE(iPA, ePA), NFC, WPT, WIFI 6E.

2.2. MEASURING INSTRUMENT CALIBRATION

The measuring equipment, which was utilized in performing the tests documented herein, has been calibrated in accordance with the manufacturer's recommendations for utilizing calibration equipment, which is traceable to recognized national standards.

2.3. TEST FACILITY

The Fully-anechoic chamber and conducted measurement facility used to collect the radiated data are located at the **74, Seoicheon-ro 578beon-gil, Majang-myeon, Icheon-si, Gyeonggi-do, 17383, Rep. of KOREA.**

3. DESCRIPTION OF TESTS

3.1 TEST PROCEDURE

Test Description	Test Procedure Used
Occupied Bandwidth	- KDB 971168 D01 v03r01 – Section 4.3 - ANSI C63.26-2015 – Section 5.4.4
Channel Edge	- KDB 971168 D01 v03r01 – Section 6.0 - ANSI C63.26-2015 – Section 5.7
Spurious and Harmonic Emissions at Antenna Terminal	- KDB 971168 D01 v03r01 – Section 6.0 - ANSI C63.26-2015 – Section 5.7
Conducted Output Power	- KDB 971168 D01 v03r01 - Section 5.2.4 - ANSI C63.26-2015 - Section 5.2.1 & 5.2.4.2
Frequency stability	- ANSI C63.26-2015 – Section 5.6
Effective Radiated Power/ Effective Isotropic Radiated Power	- KDB 971168 D01 v03r01 – Section 5.2 & 5.8 - ANSI/TIA-603-E-2016 – Section 2.2.17
Radiated Spurious and Harmonic Emissions	- KDB 971168 D01 v03r01 – Section 6.2 - ANSI/TIA-603-E-2016 – Section 2.2.12

3.2 CONDUCTED OUTPUT POWER

Test Overview

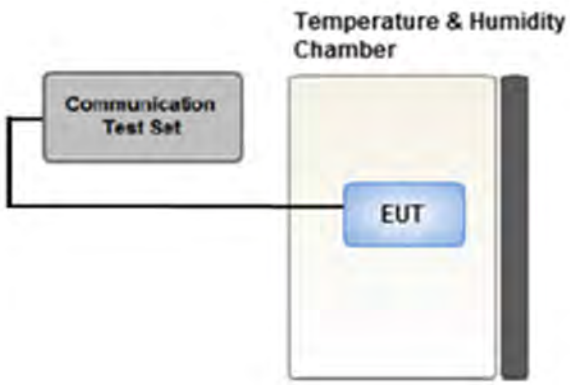
According to ANSI C63.26-2015 Section 5.2.1 when measuring the maximum RF output power from such devices, control over the EUT must be provided either through special test software (provided by manufacturer specifically for compliance testing, but not accessible by an end user) or through use of a base station emulator, communications test set, call box, or similar instrumentation that is capable of establishing a communications link with the EUT to enable control over variable parameters (e.g., output power, OBW, etc.).

In some cases, these instruments also include basic digital spectrum analyzer and/or power meter capabilities that can be utilized to measure the RF output power if the specified detectors and requirements can be realized and the measurement functions have been calibrated.

Test Procedure

1. The RF port of the EUT was connected to the Communication Tester via an RF cable.
2. Conducted average power was measured using a calibrated Radio Communication Tester.

Test setup



3.3 RADIATED POWER

Test Overview

Radiated tests are performed in the Fully-anechoic chamber.
The equipment under test is placed on a non-conductive table 3-meters away from the receive antenna in accordance with ANSI/TIA-603-E-2016 Clause 2.2.17.

Test Settings

1. Radiated power measurements are performed using the signal analyzer's "channel power" measurement capability for signals with continuous operation.
2. RBW = 1 – 5 % of the expected OBW, not to exceed 1 MHz
3. VBW ≥ 3 x RBW
4. Span = 1.5 times the OBW
5. No. of sweep points > 2 x span / RBW
6. Detector = RMS
7. Trigger is set to "free run" for signals with continuous operation with the sweep times set to "auto".
8. The integration bandwidth was roughly set equal to the measured OBW of the signal for signals with continuous operation.
9. Trace mode = trace averaging (RMS) over 100 sweeps
10. The trace was allowed to stabilize

Test Note

1. The turntable is rotated through 360 degrees, and the receiving antenna scans in order to determine the level of the maximized emission.
2. A half wave dipole is then substituted in place of the EUT. For emissions above 1 GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator and the previously recorded signal was duplicated.
   The power is calculated by the following formula;

$$P_{d\ (dBm)} = Pg_{\ (dBm)} - \text{cable loss}_{\ (dB)} + \text{antenna gain}_{\ (dB)}$$

   Where: P_d is the dipole equivalent power and P_g is the generator output power into the substitution antenna.
3. The maximum value is calculated by adding the forward power to the calibrated source plus its appropriate gain value.
   These steps are repeated with the receiving antenna in both vertical and horizontal polarization.
   the difference between the gain of the horn and an isotropic antenna are taken into consideration
4. The EUT was tested in three orthogonal planes(X, Y, Z) and in all possible test configurations and positioning.
5. All measurements are performed as RMS average measurements while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies.

3.4 RADIATED SPURIOUS EMISSIONS

Test Overview

Radiated tests are performed in the Fully-anechoic chamber.

Radiated Spurious Emission Measurements at 3 meters by Substitution Method according to ANSI/TIA-603-E-2016.

Test Settings

1. RBW = 100 kHz for emissions below 1 GHz and 1 MHz for emissions above 1 GHz
2. VBW ≥ 3 x RBW
3. Span = 1.5 times the OBW
4. No. of sweep points > 2 x span / RBW
5. Detector = Peak
6. Trace mode = Max Hold
7. The trace was allowed to stabilize
8. Test channel : Low/ Middle/ High
9. Frequency range : We are performed all frequency to 10^{th} harmonics from 9 kHz.

Test Note

1. Measurements value show only up to 3 maximum emissions noted, or would be lesser if no specific emissions from the EUT are recorded (ie: margin > 20 dB from the applicable limit) and considered that's already beyond the background noise floor.
2. The EUT was tested in three orthogonal planes(X, Y, Z) and in all possible test configurations and positioning.
   The worst case emissions are reported with the EUT positioning, modulations, RB sizes and offsets, and channel bandwidth configurations shown in the test data
3. For spurious emissions above 1 GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator and the previously recorded signal was duplicated.
   The spurious emissions is calculated by the following formula;

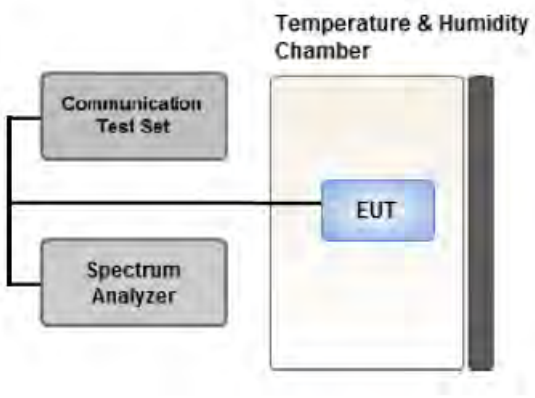
$$\text{Result}_{(dBm)} = \text{Pg}_{(dBm)} - \text{cable loss}_{(dB)} + \text{antenna gain}_{(dBi)}$$

   Where: P_g is the generator output power into the substitution antenna.

   If the fundamental frequency is below 1 GHz, RF output power has been converted to EIRP.

$$\text{EIRP}_{(dBm)} = \text{ERP}_{(dBm)} + 2.15$$

3.5 OCCUPIED BANDWIDTH.



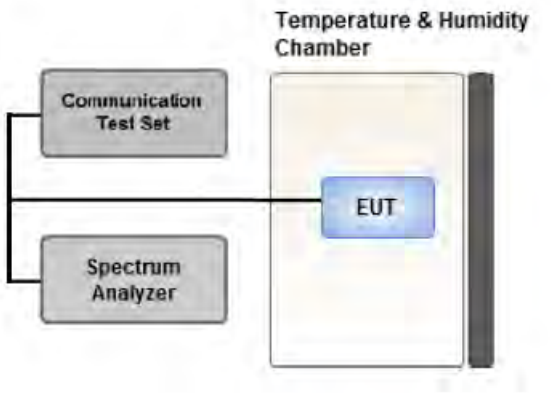
Test setup

The width of a frequency band such that, below the lower and above the upper frequency limits, the mean powers emitted are each equal to a specified percentage 0.5 % of the total mean power of a given emission.
The EUT makes a call to the communication simulator.
The conducted occupied bandwidth used the power splitter via EUT RF power connector between simulation base station and spectrum analyzer.
The communication simulator station system controlled a EUT to export maximum output power under transmission mode and specific channel frequency. Use OBW measurement function of Spectrum analyzer to measure 99 % occupied bandwidth

Test Settings

1. The signal analyzer's automatic bandwidth measurement capability was used to perform the 99 % occupied bandwidth and the 26 dB bandwidth. The bandwidth measurement was not influenced by any intermediate power nulls in the fundamental emission.
2. RBW = 1 – 5 % of the expected OBW
3. VBW ≥ 3 x RBW
4. Detector = Peak
5. Trace mode = max hold
6. Sweep = auto couple
7. The trace was allowed to stabilize
8. If necessary, steps 2 – 7 were repeated after changing the RBW such that it would be within 1 – 5 % of the 99 % occupied bandwidth observed in Step 7

3.6 SPURIOUS AND HARMONIC EMISSIONS AT ANTENNA TERMINAL



Test setup

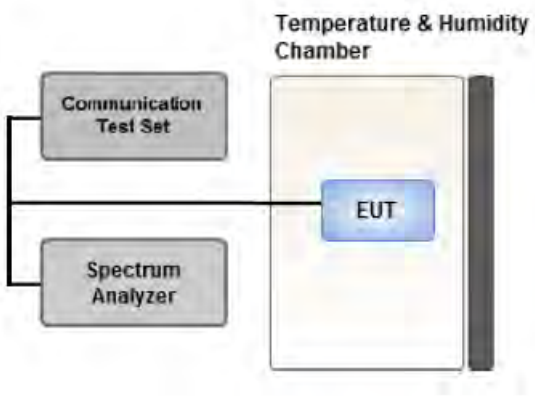
Test Overview

The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

Test Settings

1. RBW = 1 MHz
2. VBW ≥ 3 MHz
3. Detector = RMS
4. Trace Mode = trace average
5. Sweep time = auto
6. Number of points in sweep ≥ 2 x Span / RBW

3.7 CHANNEL EDGE



Test setup

Test Overview

All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

Test Settings

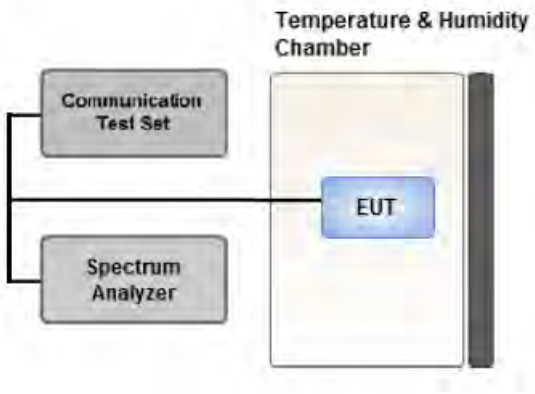
1. Start and stop frequency were set such that the band edge would be placed in the center of the plot
2. Span was set large enough so as to capture all out of band emissions near the band edge
3. RBW :
   .- EA licensee's frequency block by up to and including 37.5 kHz : 300 Hz
   .- EA licensee's frequency block greater than 37.5 kHz : 100 kHz
4. VBW > 3 x RBW
5. Detector = RMS
6. Number of sweep points ≥ 2 x Span/RBW
7. Trace mode = trace average
8. Sweep time = auto couple
9. The trace was allowed to stabilize

Test Notes

For 90.691(a), RBW=300 Hz for offset less than 37.5 kHz from channel edge and RBW=100 kHz for offsets greater than 37.5 kHz is allowed.

Where Margin < 1 dB the emission level is either corrected by 10 log(1 MHz/ RB) or the emission is integrated over a 1 MHz bandwidth to determine the final result. When using the integration method the integration window is either centered on the emission or, for emissions at the band edge, centered by an offset of 500 kHz from the block edge so that the integration window is the 1 MHz adjacent to the block edge

3.8 FREQUENCY STABILITY / VARIATION OF AMBIENT TEMPERATURE



Test setup

Test Overview

Frequency stability testing is performed in accordance with the guidelines of ANSI C63.26-2015.
The frequency stability of the transmitter is measured by:

1. Temperature:
   The temperature is varied from -30 °C to +50 °C in 10 °C increments using an environmental chamber.
2. Primary Supply Voltage:
   .- Unless otherwise specified, vary primary supply voltage from 85 % to 115 % of the nominal value for other than hand carried battery equipment.
   .- For hand carried, battery powered equipment, reduce the primary ac or dc supply voltage to the battery operating end point, which shall be specified by the manufacturer.

Test Settings

1. The carrier frequency of the transmitter is measured at room temperature (20 °C to provide a reference).
2. The equipment is turned on in a "standby" condition for fifteen minutes before applying power to the transmitter.
   Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
3. Frequency measurements are made at 10 °C intervals ranging from -30 °C to +50 °C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

3.9 WORST CASE(RADIATED TEST)

- Waveform : All Waveform of operation were investigated and the worst case configuration results are reported.
  (Worst case: DFT-S-OFDM)
- The EUT was tested in three orthogonal planes(X, Y, Z) and in all possible test configurations and positioning.
- The EUT was tested in three modes(Open, Half-open, Closed), the worst case configuration results are reported. (Worst case: Open mode)
- All modes of operation were investigated and the worst case configuration results are reported.
  Mode: SA Only
  Mode : Stand alone, Stand alone + External accessories (Earphone, AC adapter, etc)
  Worst case : Stand alone
- We were performed the RSE test in condition of co-location.
  Mode : Stand alone, Simultaneous transmission scenarios
  Worst case : Stand alone
- All RB sizes, offsets of operation were investigated and the worst case configuration results are reported.
  Please refer to the table below.
- In the case of radiated spurious emissions, all bandwidth of operation was investigated and the worst case bandwidth results are reported. (Worst case : 5 MHz)
- SM-F741U & additional models were tested and the worst case results are reported.
  (Worst case : SM-F741U)

[Worst case]

Test Description	Modulation	RB size	RB offset	Axis
Effective Radiated Power	PI/2 BPSK, QPSK, 16QAM, 64QAM, 256QAM	See Section 8.1		X
Radiated Spurious and Harmonic Emissions	PI/2 BPSK	See Section 8.1		X

3.10 WORST CASE(CONDUCTED TEST)

- Waveform : All Waveform of operation were investigated and the worst case configuration results are reported.
  (Worst case: DFT-S-OFDM)
- Modulation : All Modulation of operation were investigated and the worst case configuration results are reported.
  (Worst case: PI/2 BPSK)
- All modes of operation were investigated and the worst case configuration results are reported.
  Mode: NSA, SA
  Worst case: SA Only
- All RB sizes, offsets of operation were investigated and the worst case configuration results are reported.
  Please refer to the table below.
- SM-F741U & additional models were tested and the worst case results are reported.
  (Worst case : SM-F741U)

[Worst case]

Test Description	Modulation	Bandwidth (MHz)	Frequency	RB size	RB offset
Occupied Bandwidth	PI/2 BPSK QPSK, 16QAM, 64QAM, 256QAM	5	High	Full RB	0
	PI/2 BPSK, QPSK, 16QAM, 64QAM, 256QAM	10, 15, 20	Mid	Full RB	0
Channel Edge	PI/2 BPSK,	5	Low	1	0
			High	1	24
		10	Mid	1	0
				1	51
		15	Mid	1	0
				1	78
		20	Mid	1	0
				1	105
		5	Low, High	Full RB	0
		10, 15, 20	Mid	Full RB	0
Spurious and Harmonic Emissions at Antenna Terminal	PI/2 BPSK,	5	Low, High	1	1
		10, 15, 20	Mid	1	1

4. LIST OF TEST EQUIPMENT

Equipment	Model	Manufacture	Serial No.	Due to Calibration	Calibration Interval
Precision Dipole Antenna	UHAP	Schwarzbeck	01273	03/10/2026	Biennial
Precision Dipole Antenna	UHAP	Schwarzbeck	01274	03/10/2026	Biennial
Horn Antenna(1~18 GHz)	BBHA 9120D	Schwarzbeck	02289	02/14/2026	Biennial
Horn Antenna(1~18 GHz)	BBHA 9120D	Schwarzbeck	9120D-1299	04/27/2025	Biennial
Horn Antenna(15~40 GHz)	BBHA 9170	Schwarzbeck	BBHA9170342	09/29/2024	Biennial
Horn Antenna(15~40 GHz)	BBHA 9170	Schwarzbeck	BBHA9170124	03/28/2025	Biennial
Loop Antenna(9 kHz~30 MHz)	FMZB1513	Rohde & Schwarz	1513-175	01/16/2025	Biennial
Bilog Antenna	VULB9160	Schwarzbeck	3150	03/09/2025	Biennial
Hybrid Antenna	VULB9160	Schwarzbeck	760	02/24/2025	Biennial
RF Switching System	FBSR-06B (1G HPF + LNA)	T&M SYSTEM	F3L1	05/22/2024	Annual
RF Switching System	FBSR-06B (3G HPF + LNA)	T&M SYSTEM	F3L2	05/22/2024	Annual
RF Switching System	FBSR-06B (6G HPF + LNA)	T&M SYSTEM	F3L3	05/22/2024	Annual
RF Switching System	FBSR-06B (LNA)	T&M SYSTEM	F3L4	05/22/2024	Annual
Power Amplifier	CBL18265035	CERNEX	22966	11/17/2024	Annual
Power Amplifier	CBL26405040	CERNEX	25956	02/26/2025	Annual
DC Power Supply	E3632A	Hewlett Packard	MY40004427	08/25/2024	Annual
Power Splitter(DC~26.5 GHz)	11667B	Hewlett Packard	11275	02/29/2025	Annual
Chamber	SU-642	ESPEC	93008124	02/19/2025	Annual
Signal Analyzer(10 Hz~26.5 GHz)	N9020A	Agilent	MY51110063	04/04/2025	Annual
ATTENUATOR(20 dB)	8493C	Hewlett Packard	17280	04/17/2025	Annual
Spectrum Analyzer(10 Hz~40 GHz)	FSV40	REOHDE & SCHWARZ	101436	02/13/2025	Annual
Base Station	8960 (E5515C)	Agilent	MY48360800	08/10/2024	Annual
Wideband Radio Communication Tester	MT8821C	Anritsu Corp.	6262287701	05/22/2024	Annual
Wideband Radio Communication Tester	MT8000A	Anritsu Corp.	6262302511	05/23/2024	Annual
SIGNAL GENERATOR (100 kHz~40 GHz)	SMB100A	REOHDE & SCHWARZ	177633	06/22/2024	Annual
Signal Analyzer(5 Hz~40.0 GHz)	N9030B	KEYSIGHT	MY55480167	05/24/2024	Annual
4-Way Divider	ZC4PD-K1844+	Mini-Circuits	942907	09/19/2024	Annual
FCC LTE Mobile Conducted RF Automation Test Software	-	HCT CO., LTD.,	-	-	-

Note:

1. Equipment listed above that has a calibration due date during the testing period, the testing is completed before equipment expiration date.
2. Especially, all antenna for measurement is calibrated in accordance with the requirements of C63.5 (Version : 2017).

5. MEASUREMENT UNCERTAINTY

The measurement uncertainties shown below were calculated in accordance with the requirements of ANSI C63.4:2014.

All measurement uncertainty values are shown with a coverage factor of $k = 2$ to indicate a 95 % level of confidence. The measurement data shown herein meets or exceeds the U_{CISPR} measurement uncertainty values specified in CISPR 16-4-2 and, thus, can be compared directly to specified limits to determine compliance.

Parameter	Expanded Uncertainty (±dB)
Conducted Disturbance (150 kHz ~ 30 MHz)	1.98 (Confidence level about 95 %, k=2)
Radiated Disturbance (9 kHz ~ 30 MHz)	4.36 (Confidence level about 95 %, k=2)
Radiated Disturbance (30 MHz ~ 1 GHz)	5.70 (Confidence level about 95 %, k=2)
Radiated Disturbance (1 GHz ~ 18 GHz)	5.52 (Confidence level about 95 %, k=2)
Radiated Disturbance (18 GHz ~ 40 GHz)	5.66 (Confidence level about 95 %, k=2)
Radiated Disturbance (Above 40 GHz)	5.58 (Confidence level about 95 %, k=2)

6. SUMMARY OF TEST RESULTS

6.1 Test Condition: Conducted Test

Test Description	FCC Part Section(s)	Test Limit	Test Result
Occupied Bandwidth	§ 2.1049	N/A	PASS
Channel Edge / Spurious and Harmonic Emissions at Antenna Terminal.	§ 2.1051, § 90.691	< 50 + 10log10 (P[Watts]) at Band Edge and for all out-of-band emissions within 37.5 kHz of Block Edge	PASS
Band Edge / Spurious and Harmonic Emissions at Antenna Terminal.	§ 2.1051, § 22.917(a)	< 43 + 10log10 (P[Watts]) at Band Edge and for all out-of-band emissions	PASS
Conducted Output Power	§ 2.1046 § 90.635	< 100 Watts	PASS
Frequency stability / variation of ambient temperature	§ 2.1055, § 90.213 § 22.355	< 2.5 ppm	PASS

6.2 Test Condition: Radiated Test

Test Description	FCC Part Section(s)	Test Limit	Test Result
Effective Radiated Power	§ 22.913(a)(5)	< 7 Watts max. ERP (Only 15,20 MHz B.W & Straddle C.H)	PASS
Radiated Spurious and Harmonic Emissions	§ 2.1053, § 90.691 § 22.917(a)	< 43 + 10log10 (P[Watts]) for all out-of band emissions	PASS

7. SAMPLE CALCULATION

7.1 ERP Sample Calculation

Ch./ Freq.		Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain (dBd)	C.L	Pol.	ERP	
channel	Freq.(MHz)						W	dBm
128	824.20	-21.37	38.40	-10.61	0.95	H	0.483	26.84

ERP = Substitute LEVEL(dBm) + Ant. Gain – CL(Cable Loss)

1) The EUT mounted on a non-conductive turntable is 2.5 meter above test site ground level.
2) During the test, the turn table is rotated until the maximum signal is found.
3) Record the field strength meter's level.
4) Replace the EUT with dipole/Horn antenna that is connected to a calibrated signal generator.
5) Increase the signal generator output till the field strength meter's level is equal to the item (3).
6) The signal generator output level with Ant. Gain and cable loss are the rating of effective radiated power.

7.2 EIRP Sample Calculation

Ch./ Freq.		Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain (dBi)	C.L	Pol.	EIRP	
channel	Freq.(MHz)						W	dBm
20175	1,732.50	-15.75	18.45	9.90	1.76	H	0.456	26.59

EIRP = Substitute LEVEL(dBm) + Ant. Gain – CL(Cable Loss)

1) The EUT mounted on a non-conductive turntable is 2.5 meter above test site ground level.
2) During the test, the turn table is rotated until the maximum signal is found.
3) Record the field strength meter's level.
4) Replace the EUT with dipole/Horn antenna that is connected to a calibrated signal generator.
5) Increase the signal generator output till the field strength meter's level is equal to the item (3).
6) The signal generator output level with Ant. Gain and cable loss are the rating of equivalent isotropic radiated power.

7.3. Emission Designator

GSM Emission Designator

Emission Designator = 249KGXW
GSM BW = 249 kHz
G = Phase Modulation
X = Cases not otherwise covered
W = Combination (Audio/Data)

EDGE Emission Designator

Emission Designator = 249KG7W
GSM BW = 249 kHz
G = Phase Modulation
7 = Quantized/Digital Info
W = Combination (Audio/Data)

WCDMA Emission Designator

Emission Designator = 4M17F9W
WCDMA BW = 4.17 MHz
F = Frequency Modulation
9 = Composite Digital Info
W = Combination (Audio/Data)

QPSK Modulation

Emission Designator = 4M48G7D
LTE BW = 4.48 MHz
G = Phase Modulation
7 = Quantized/Digital Info
D = Data transmission; telemetry; telecommand

QAM Modulation

Emission Designator = 4M48W7D
LTE BW = 4.48 MHz
W = Amplitude/Angle Modulated
7 = Quantized/Digital Info
D = Data transmission; telemetry; telecommand

8. TEST DATA

8.1 CONDUCTED OUTPUT POWER

Band Width	Modulation	RB Size	RB Offset	Max. output power(dBm)						Limit (W)
				816.5 MHz		821.5 MHz		824.0 MHz		
				dBm	W	dBm	W	dBm	W	
5	BPSK	1	1	24.05	0.254	23.84	0.242	23.90	0.245	100
		1	13	24.09	0.256	23.90	0.246	23.93	0.247	100
		1	23	24.06	0.255	23.74	0.236	23.82	0.241	100
		12	0	23.46	0.222	23.42	0.220	23.36	0.217	100
		12	7	23.96	0.249	24.03	0.253	23.93	0.247	100
		12	13	23.40	0.219	23.39	0.218	23.39	0.218	100
		25	0	23.42	0.220	23.42	0.220	23.30	0.214	100
	QPSK	1	1	24.06	0.255	23.95	0.248	23.90	0.245	100
		1	13	24.17	0.261	24.01	0.252	23.96	0.249	100
		1	23	24.21	0.264	23.93	0.247	23.93	0.247	100
		12	0	22.98	0.199	22.93	0.196	22.81	0.191	100
		12	7	24.01	0.252	23.98	0.250	23.92	0.246	100
		12	13	22.86	0.193	22.90	0.195	22.84	0.193	100
		25	0	22.85	0.193	22.90	0.195	22.93	0.196	100
	16QAM	1	1	23.02	0.200	22.93	0.196	22.79	0.190	100
	64QAM	1	1	21.36	0.137	21.31	0.135	21.38	0.137	100
	256QAM	1	1	19.90	0.098	18.74	0.075	18.82	0.076	100

Band Width	Modulation	RB Size	RB Offset	Max. output power(dBm)				Limit (W)
				819.0 MHz		824.0 MHz		
				dBm	W	dBm	W	
10	BPSK	1	1	23.95	0.248	23.89	0.245	100
		1	26	24.02	0.252	24.07	0.255	100
		1	50	23.94	0.248	24.09	0.256	100
		25	0	23.38	0.218	23.42	0.220	100
		25	14	24.07	0.255	23.90	0.246	100
		25	27	23.39	0.218	23.43	0.220	100
		50	0	23.41	0.219	23.33	0.215	100
	QPSK	1	1	24.15	0.260	24.11	0.258	100
		1	26	24.27	0.267	24.16	0.260	100
		1	50	24.24	0.265	24.15	0.260	100
		25	0	22.85	0.193	22.88	0.194	100
		25	14	23.97	0.250	23.91	0.246	100
		25	27	22.88	0.194	22.88	0.194	100
		50	0	22.90	0.195	22.80	0.191	100
	16QAM	1	1	23.02	0.200	23.18	0.208	100
	64QAM	1	1	21.46	0.140	21.43	0.139	100
	256QAM	1	1	19.36	0.086	19.45	0.088	100

Band Width	Modulation	RB Size	RB Offset	Max. output power(dBm)				Limit (W)
				821.5 MHz		824.0 MHz		
				dBm	W	dBm	W	
15	BPSK	1	1	24.02	0.252	23.83	0.242	100
		1	40	24.13	0.259	23.91	0.246	100
		1	77	24.12	0.258	23.93	0.247	100
		36	0	23.37	0.217	23.26	0.212	100
		36	22	24.08	0.256	23.91	0.246	100
		36	43	23.26	0.212	23.34	0.216	100
		75	0	23.33	0.215	23.32	0.215	100
	QPSK	1	1	23.41	0.219	24.01	0.252	100
		1	40	23.49	0.223	24.03	0.253	100
		1	77	23.47	0.223	23.96	0.249	100
		36	0	22.82	0.191	22.82	0.192	100
		36	22	23.99	0.251	23.92	0.246	100
		36	43	22.83	0.192	22.91	0.195	100
		75	0	22.90	0.195	22.80	0.190	100
	16QAM	1	1	22.98	0.199	22.95	0.197	100
	64QAM	1	1	21.11	0.129	21.59	0.144	100
	256QAM	1	1	19.10	0.081	19.63	0.092	100

Band Width	Modulation	RB Size	RB Offset	Max. output power(dBm)		Limit (W)
				824.0 MHz		
				dBm	W	
20	BPSK	1	1	23.68	0.233	100
		1	53	23.75	0.237	100
		1	104	23.87	0.244	100
		50	0	23.27	0.212	100
		50	28	23.89	0.245	100
		50	56	23.33	0.215	100
		100	0	23.44	0.221	100
	QPSK	1	1	23.88	0.244	100
		1	53	23.94	0.248	100
		1	104	24.00	0.251	100
		50	0	22.82	0.192	100
		50	28	23.90	0.246	100
		50	56	22.79	0.190	100
		100	0	23.00	0.200	100
	16QAM	1	1	23.09	0.204	100
	64QAM	1	1	21.64	0.146	100
	256QAM	1	1	19.28	0.085	100

8.2 EFFECTIVE RADIATED POWER

Freq (MHz)	Mod/ Bandwidth [SCS (kHz)]	Modulation	Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain (dBd)	C.L	Pol	Limit	ERP		RB	
								W	W	dBm	Size	Offset
816.5	Sub6 n26 5 MHz [15 kHz]	PI/2 BPSK	-29.63	31.11	-10.05	1.38	H	< 100	0.093	19.68	1	1
		QPSK	-29.77	30.97	-10.05	1.38	H		0.090	19.54		
		16-QAM	-30.76	29.98	-10.05	1.38	H		0.072	18.55		
		64-QAM	-32.12	28.62	-10.05	1.38	H		0.052	17.19		
		256-QAM	-34.58	26.16	-10.05	1.38	H		0.030	14.73		
821.5		PI/2 BPSK	-29.69	31.23	-10.05	1.38	H		0.095	19.80	1	1
		QPSK	-29.75	31.17	-10.05	1.38	H		0.094	19.74		
		16-QAM	-30.76	30.16	-10.05	1.38	H		0.075	18.73		
		64-QAM	-32.13	28.79	-10.05	1.38	H		0.054	17.36		
		256-QAM	-34.72	26.20	-10.05	1.38	H		0.030	14.77		
824.0		PI/2 BPSK	-29.81	31.09	-10.05	1.38	H	< 7.00	0.093	19.66	1	1
		QPSK	-29.96	30.94	-10.05	1.38	H		0.089	19.51		
		16-QAM	-30.99	29.91	-10.05	1.38	H		0.071	18.48		
		64-QAM	-32.31	28.59	-10.05	1.38	H		0.052	17.16		
		256-QAM	-34.87	26.03	-10.05	1.38	H		0.029	14.60		

Freq (MHz)	Mod/ Bandwidth [SCS (kHz)]	Modulation	Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain (dBd)	C.L	Pol	Limit	ERP		RB	
								W	W	dBm	Size	Offset
819.0	Sub6 n26 10 MHz [15 kHz]	PI/2 BPSK	-29.69	31.05	-10.05	1.38	H	< 100	0.092	19.62	1	1
		QPSK	-29.76	30.98	-10.05	1.38	H		0.090	19.55		
		16-QAM	-30.79	29.95	-10.05	1.38	H		0.071	18.52		
		64-QAM	-32.07	28.67	-10.05	1.38	H		0.053	17.24		
		256-QAM	-34.72	26.02	-10.05	1.38	H		0.029	14.59		
824.0		PI/2 BPSK	-29.69	31.21	-10.05	1.38	H	< 7.00	0.095	19.78	1	1
		QPSK	-29.70	31.20	-10.05	1.38	H		0.095	19.77		
		16-QAM	-30.88	30.02	-10.05	1.38	H		0.072	18.59		
		64-QAM	-32.18	28.72	-10.05	1.38	H		0.054	17.29		
		256-QAM	-34.78	26.12	-10.05	1.38	H		0.030	14.69		

Freq (MHz)	Mod/ Bandwidth [SCS (kHz)]	Modulation	Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain (dBd)	C.L	Pol	Limit	ERP		RB	
								W	W	dBm	Size	Offset
821.5	Sub6 n26 15 MHz [15 kHz]	PI/2 BPSK	-29.65	31.27	-10.05	1.38	H	< 7.00	0.096	19.84	1	1
		QPSK	-29.67	31.25	-10.05	1.38	H		0.096	19.82		
		16-QAM	-30.74	30.18	-10.05	1.38	H		0.075	18.75		
		64-QAM	-32.14	28.78	-10.05	1.38	H		0.054	17.35		
		256-QAM	-34.69	26.23	-10.05	1.38	H		0.030	14.80		
824.0		PI/2 BPSK	-29.67	31.23	-10.05	1.38	H		0.096	19.80	1	1
		QPSK	-29.69	31.21	-10.05	1.38	H		0.095	19.78		
		16-QAM	-30.89	30.01	-10.05	1.38	H		0.072	18.58		
		64-QAM	-32.15	28.75	-10.05	1.38	H		0.054	17.32		
		256-QAM	-34.63	26.27	-10.05	1.38	H		0.031	14.84		

Freq (MHz)	Mod/ Bandwidth [SCS (kHz)]	Modulation	Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain (dBd)	C.L	Pol	Limit	ERP		RB	
								W	W	dBm	Size	Offset
824.0	Sub6 n26 20 MHz [15 kHz]	PI/2 BPSK	-29.68	31.22	-10.05	1.38	H	< 7.00	0.095	19.79	1	1
		QPSK	-29.71	31.19	-10.05	1.38	H		0.095	19.76		
		16-QAM	-30.77	30.13	-10.05	1.38	H		0.074	18.70		
		64-QAM	-32.06	28.84	-10.05	1.38	H		0.055	17.41		
		256-QAM	-34.68	26.22	-10.05	1.38	H		0.030	14.79		

8.3 RADIATED SPURIOUS EMISSIONS

▣ NR Band: N26

▣ Bandwidth: 5 MHz

▣ Modulation: PI/2 BPSK

▣ Distance: 3 meters

▣ SCS: 15 kHz

Ch	Freq (MHz)	Measured Level (dBm)	Ant. Gain (dBi)	Substitute Level (dBm)	C.L	Pol	Result (dBm)	Limit (dBm)	RB	
									Size	Offset
163300 (816.5)	1 633.00	-56.32	9.20	-65.23	2.03	V	-58.06	-13.00	1	1
	2 449.50	-59.53	10.20	-62.78	2.45	V	-55.03	-13.00		
	3 266.00	-60.91	10.90	-62.95	2.92	V	-54.97	-13.00		
	4 082.50	-64.08	11.30	-63.93	3.25	V	-55.88	-13.00		
	4 899.00	-60.82	10.90	-56.53	3.58	V	-49.21	-13.00		
164300 (821.5)	1 643.00	-56.32	9.40	-64.94	2.00	V	-57.54	-13.00	1	1
	2 464.50	-60.02	10.30	-64.85	2.52	V	-57.07	-13.00		
	3 286.00	-60.73	11.00	-63.21	2.94	V	-55.15	-13.00		
	4 107.50	-61.82	11.20	-60.90	3.28	V	-52.98	-13.00		
	4 929.00	-62.59	10.70	-57.43	3.61	V	-50.34	-13.00		

▣ NR Band: N26

▣ Bandwidth: 15 MHz

▣ Modulation: PI/2 BPSK

▣ Distance: 3 meters

▣ SCS: 15 kHz

Ch	Freq (MHz)	Measured Level (dBm)	Ant. Gain (dBi)	Substitute Level (dBm)	C.L	Pol	Result (dBm)	Limit (dBm)	RB	
									Size	Offset
164300 (821.5)	1 643.00	-58.19	9.40	-66.81	2.00	V	-59.41	-13.00	1	1
	2 464.50	-59.28	10.30	-64.11	2.52	V	-56.33	-13.00		
	3 286.00	-60.08	11.00	-62.56	2.94	V	-54.50	-13.00		
	4 107.50	-63.21	11.20	-62.29	3.28	V	-54.37	-13.00		
	4 929.00	-61.92	10.70	-56.76	3.61	V	-49.67	-13.00		
164800 (824.0)	1 648.00	-57.96	9.20	-66.95	2.02	V	-59.77	-13.00	1	1
	2 472.00	-59.75	10.20	-63.89	2.49	V	-56.18	-13.00		
	3 296.00	-60.34	10.75	-62.69	2.91	V	-54.85	-13.00		
	4 120.00	-61.19	11.30	-60.48	3.22	V	-52.40	-13.00		
	4 944.00	-62.28	11.00	-57.80	3.60	V	-50.40	-13.00		

8.4 OCCUPIED BANDWIDTH

Band	Band Width	Frequency (MHz)	Modulation	Resource Block Size	Resource Block Offset	Data (MHz)
Band 26	5 MHz	821.5	BPSK	25	0	4.4672
			QPSK			4.5305
			16QAM			4.4995
			64QAM			4.5126
			256QAM			4.5001
	10 MHz	819.0	BPSK	50		8.9508
			QPSK			9.0135
			16QAM			8.9729
			64QAM			8.9835
			256QAM			8.9514
	15 MHz	** 821.5	BPSK	75		13.458
			QPSK			13.500
			16QAM			13.417
			64QAM			13.493
			256QAM			13.500
	20 MHz	** 824.0	BPSK	100		17.924
			QPSK			17.949
			16QAM			17.931
			64QAM			17.893
			256QAM			17.887

Note:

1. Plots of the EUT's Occupied Bandwidth are shown Page 41 ~ 60.
2. **: Straddle Channel
3. Straddle channel does not exceed the Part22 and Part90 limits.

8.5 CONDUCTED SPURIOUS EMISSIONS

Band	Band Width (MHz)	Frequency (MHz)	Frequency of Maximum Harmonic (GHz)	Factor (dB)	Measurement Maximum Data (dBm)	Result (dBm)	Limit (dBm)
26	5	816.5	9.9970	31.315	-75.087	-43.772	-13.00
		821.5	8.0070	31.315	-74.712	-43.397	
		** 824.0	9.9586	31.315	-74.557	-43.242	
	10	819.0	7.7548	31.315	-74.043	-42.728	
		** 824.0	4.0574	30.700	-74.873	-44.173	
	15	** 821.5	9.1182	31.315	-73.714	-42.399	
		** 824.0	9.9412	31.315	-73.968	-42.653	
	20	** 824.0	5.2129	31.315	-74.254	-42.939	

Note:

1. Plots of the EUT's Conducted Spurious Emissions are shown Page 87 ~ 94.
2. Result (dBm) = Measurement Maximum Data (dBm) + Factor (dB)
3. Factor (dB) = Cable Loss + Ext. Attenuator + Power Splitter

Frequency Range (GHz)	Factor [dB]
0.03 – 1	27.994
1 – 5	30.700
5 – 10	31.315
10 – 15	31.840
15 – 20	32.213
Above 20	32.855

5. **: Straddle Channel
6. Straddle channel does not exceed the Part22 and Part90 limit

8.6 CHANNEL EDGE (Part90)

- Test Channel : 164800(824.0MHz)
- Plots of the EUT's Band Edge are shown Page 61 ~ 76.

8.7 BAND EDGE(Part22)

- Test Channel : 164800(824.0 MHz)
- Plots of the EUT's Band Edge are shown Page 77 ~ 86.

8.8 FREQUENCY STABILITY / VARIATION OF AMBIENT TEMPERATURE

▣ BandWidth: 5 MHz

▣ Voltage(100 %): 3.880 VDC

▣ Batt. Endpoint: 3.300 VDC

▣ LIMIT: Emission must remain in band

Test. Frequncy	Voltage	Temp.	Frequency	Frequency Error	Deviation	ppm
(MHz)	(%)	(°C)	(Hz)	(Hz)	(%)	
821.5	100 %	+20(Ref)	821 499 995	0.0	0.000 000	0.000
	100 %	-30	821 499 991	-4.5	-0.000 001	-0.005
	100 %	-20	821 499 991	-4.5	-0.000 001	-0.005
	100 %	-10	821 499 991	-4.4	-0.000 001	-0.005
	100 %	0	821 499 991	-4.2	-0.000 001	-0.005
	100 %	+10	821 499 991	-4.4	-0.000 001	-0.005
	100 %	+30	821 499 991	-4.4	-0.000 001	-0.005
	100 %	+40	821 499 991	-4.5	-0.000 001	-0.005
	100 %	+50	821 499 991	-4.3	-0.000 001	-0.005
	Batt. Endpoint	+20	821 499 991	-4.4	-0.000 001	-0.005

▣ BandWidth: 10 MHz

▣ Voltage(100 %): 3.880 VDC

▣ Batt. Endpoint: 3.300 VDC

▣ LIMIT: Emission must remain in band

Test. Frequncy	Voltage	Temp.	Frequency	Frequency Error	Deviation	ppm
(MHz)	(%)	(°C)	(Hz)	(Hz)	(%)	
819.0	100 %	+20(Ref)	819 000 004	0.0	0.000 000	0.000
	100 %	-30	819 000 007	3.5	0.000 000	0.004
	100 %	-20	819 000 007	3.5	0.000 000	0.004
	100 %	-10	819 000 007	3.6	0.000 000	0.004
	100 %	0	819 000 007	3.8	0.000 000	0.005
	100 %	+10	819 000 007	3.6	0.000 000	0.004
	100 %	+30	819 000 007	3.7	0.000 000	0.005
	100 %	+40	819 000 007	3.9	0.000 000	0.005
	100 %	+50	819 000 008	4.2	0.000 001	0.005
	Batt. Endpoint	+20	819 000 008	4.0	0.000 000	0.005

▣ BandWidth: 15 MHz

▣ Voltage(100 %): 3.880 VDC

▣ Batt. Endpoint: 3.300 VDC

▣ LIMIT: Emission must remain in band

Test. Frequncy	Voltage	Temp.	Frequency	Frequency Error	Deviation	ppm
(MHz)	(%)	(°C)	(Hz)	(Hz)	(%)	
** 821.5	100 %	+20(Ref)	821 500 002	0.0	0.000 000	0.000
	100 %	-30	821 500 002	0.2	0.000 000	0.000
	100 %	-20	821 500 002	0.4	0.000 000	0.000
	100 %	-10	821 500 001	-0.5	0.000 000	-0.001
	100 %	0	821 500 001	-0.3	0.000 000	0.000
	100 %	+10	821 500 001	-0.4	0.000 000	-0.001
	100 %	+30	821 500 003	1.7	0.000 000	0.002
	100 %	+40	821 500 003	1.0	0.000 000	0.001
	100 %	+50	821 500 001	-0.5	0.000 000	-0.001
	Batt. Endpoint	+20	821 500 003	1.5	0.000 000	0.002

Note:

1. **: Straddle Channel

2. Straddle channel does not exceed the Part22 and Part90 limits.

▣ BandWidth: 20 MHz

▣ Voltage(100 %): 3.880 VDC

▣ Batt. Endpoint: 3.300 VDC

▣ LIMIT: Emission must remain in band

Test. Frequncy	Voltage	Temp.	Frequency	Frequency Error	Deviation	ppm
(MHz)	(%)	(°C)	(Hz)	(Hz)	(%)	
** 824.0	100 %	+20(Ref)	824 000 002	0.0	0.000 000	0.000
	100 %	-30	824 000 003	0.7	0.000 000	0.001
	100 %	-20	824 000 003	1.3	0.000 000	0.002
	100 %	-10	824 000 003	1.3	0.000 000	0.002
	100 %	0	824 000 004	1.4	0.000 000	0.002
	100 %	+10	824 000 004	1.9	0.000 000	0.002
	100 %	+30	824 000 002	-0.2	0.000 000	0.000
	100 %	+40	824 000 002	0.0	0.000 000	0.000
	100 %	+50	824 000 002	0.1	0.000 000	0.000
	Batt. Endpoint	+20	824 000 002	0.0	0.000 000	0.000

Note:

1. **: Straddle Channel

2. Straddle channel does not exceed the Part22 and Part90 limits.

9. TEST PLOTS

Sub6 n26. Occupied Bandwidth Plot (5 M BW Ch.164300 BPSK RB 25_0)

Sub6 n26. Occupied Bandwidth Plot (5 M BW Ch.164300 QPSK RB 25_0)

Sub6 n26. Occupied Bandwidth Plot (5 M BW Ch.164300 16QAM RB 25_0)

Sub6 n26. Occupied Bandwidth Plot (5 M BW Ch.164300 64QAM RB 25_0)

Sub6 n26. Occupied Bandwidth Plot (5 M BW Ch.164300 256QAM RB 25_0)

Sub6 n26. Occupied Bandwidth Plot (10 M BW Ch.163800 BPSK RB 50_0)

Sub6 n26. Occupied Bandwidth Plot (10 M BW Ch.163800 QPSK RB 50_0)

Sub6 n26. Occupied Bandwidth Plot (10 M BW Ch.163800 16QAM RB 50_0)

Sub6 n26. Occupied Bandwidth Plot (10 M BW Ch.163800 64QAM RB 50_0)

Sub6 n26. Occupied Bandwidth Plot (10 M BW Ch.163800 256QAM RB 50_0)

Sub6 n26. Occupied Bandwidth Plot (15 M BW Ch.164300 BPSK RB 75_0)

Sub6 n26. Occupied Bandwidth Plot (15 M BW Ch.164300 QPSK RB 75_0)

Sub6 n26. Occupied Bandwidth Plot (15 M BW Ch.164300 16QAM RB 75_0)

Sub6 n26. Occupied Bandwidth Plot (15 M BW Ch.164300 64QAM RB 75_0)

Sub6 n26. Occupied Bandwidth Plot (15 M BW Ch.164300 256QAM RB 100_0)

Sub6 n26. Occupied Bandwidth Plot (20 M BW Ch.164800 BPSK RB 100_0)

Sub6 n26. Occupied Bandwidth Plot (20 M BW Ch.164800 QPSK RB 100_0)

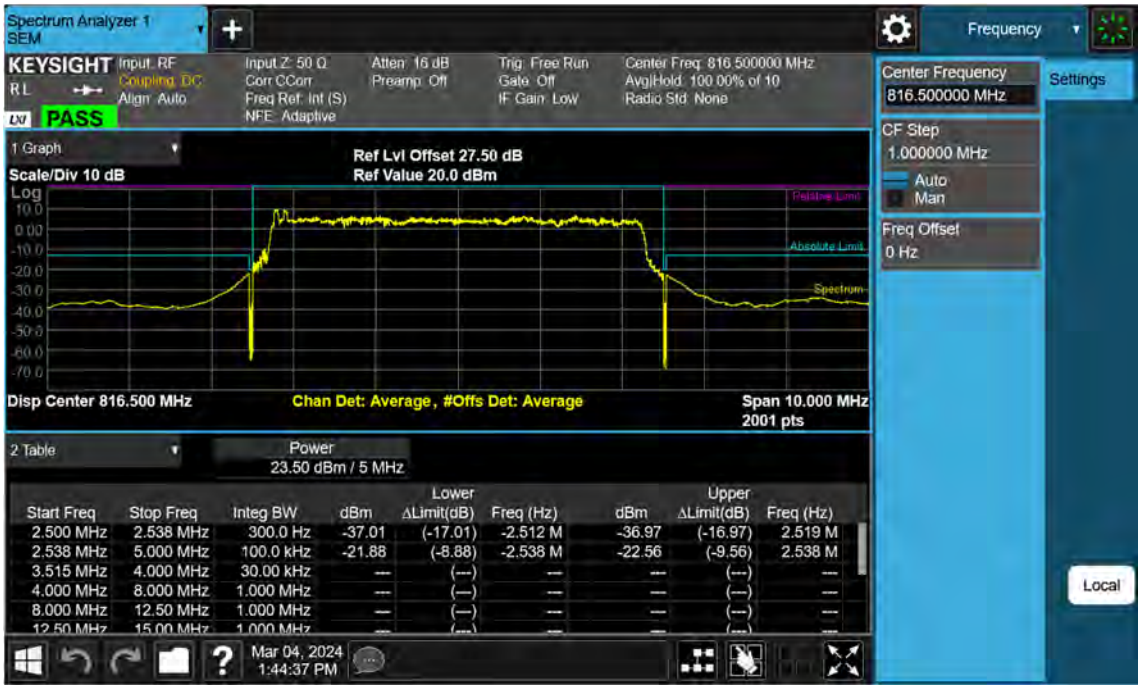
Sub6 n26. Occupied Bandwidth Plot (20 M BW Ch.164800 16QAM RB 100_0)

Sub6 n26. Occupied Bandwidth Plot (20 M BW Ch.164800 64QAM RB 100_0)

Sub6 n26. Occupied Bandwidth Plot (20 M BW Ch.164800 256QAM RB 100_0)

Sub6 n26. Lower Channel Edge Plot (5 M BW Ch.163300 BPSK RB 1, Offset 0)

Sub6 n26. Lower Channel Edge Plot (5 M BW Ch.163300 BPSK_RB25_Offset 0)

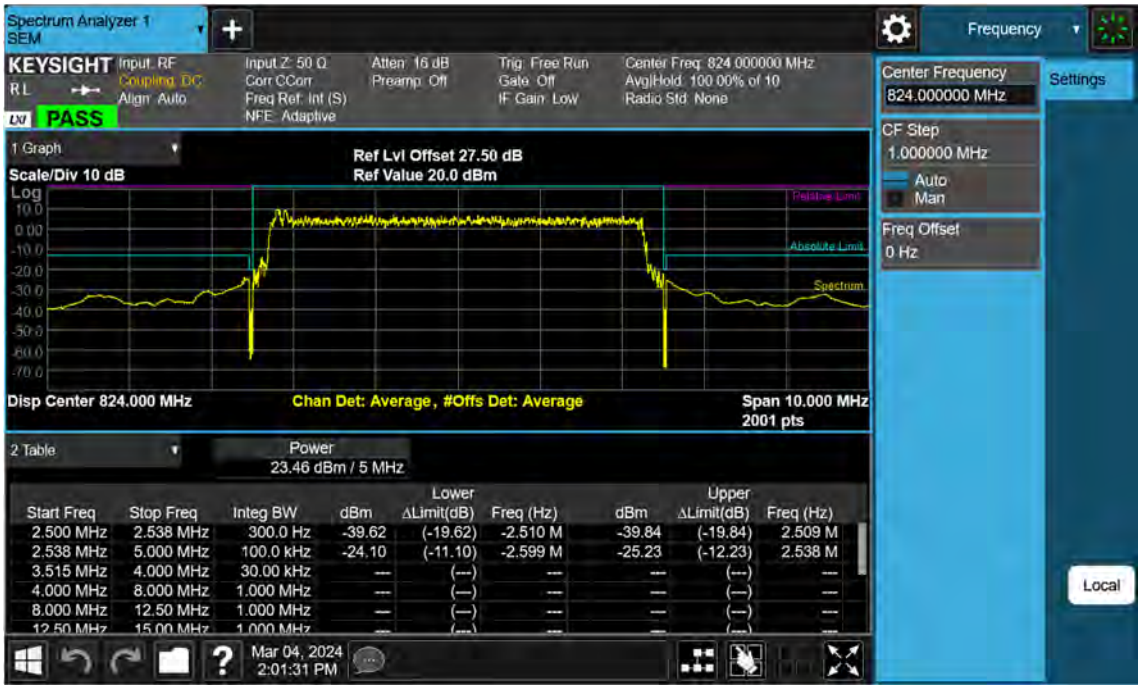


Sub6 n26. Mid Channel Edge Plot (5 M BW Ch.164300 BPSK_RB1_Offset 0)

Sub6 n26. Mid Channel Edge Plot (5 M BW Ch.164300 BPSK_ RB25_Offset 0)

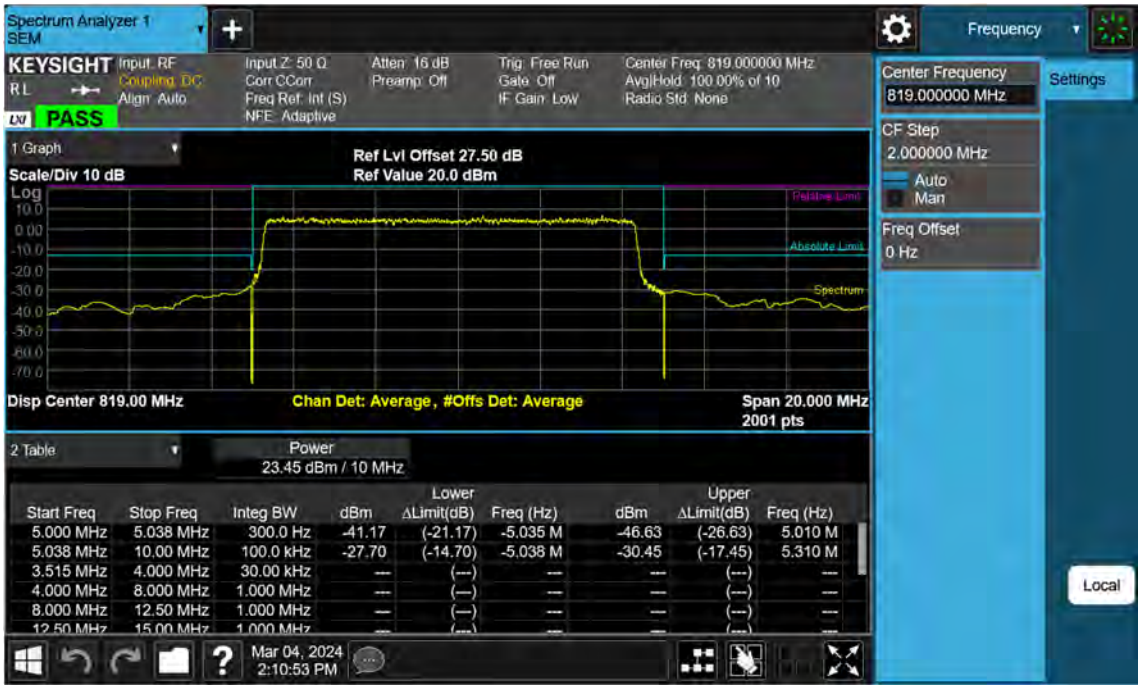
Sub6 n26. Upper Channel Edge Plot (5 M BW Ch.164800 BPSK_RB1_Offset 24)

Sub6 n26. Upper Channel Edge Plot (5 M BW Ch.164800 BPSK_RB25_Offset 0)

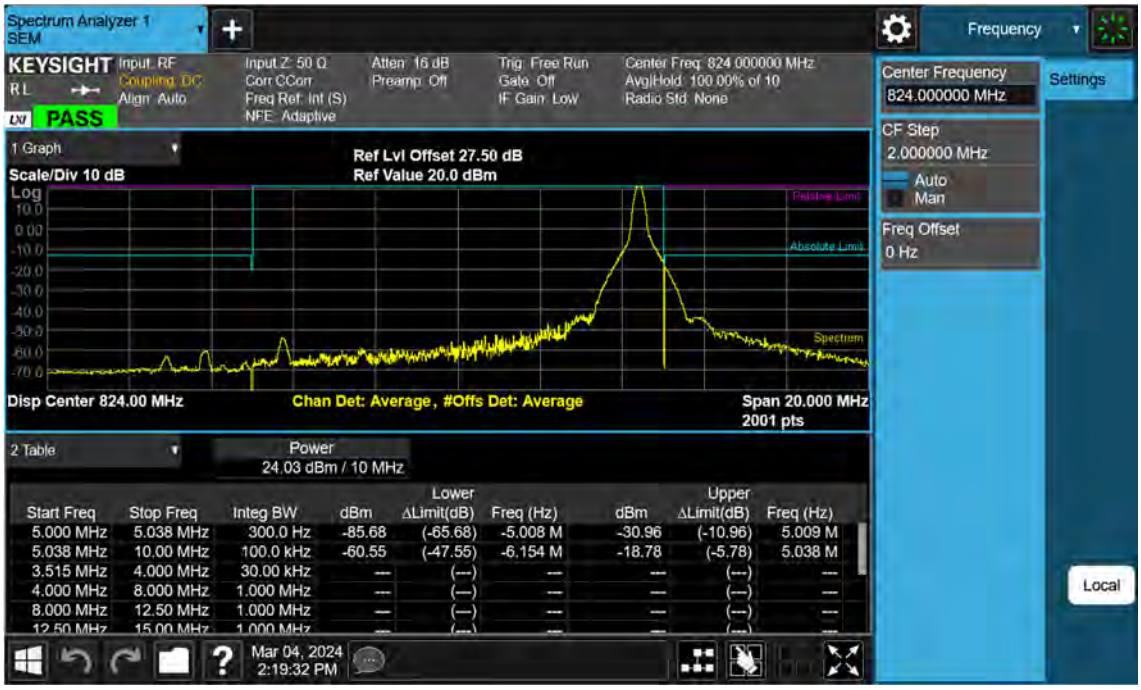


Sub6 n26. Low Channel Edge Plot (10 M BW Ch.163800 BPSK RB 1, Offset 0)

Sub6 n26. Low Channel Edge Plot (10 M BW Ch.163800 BPSK_RB50_Offset 0)

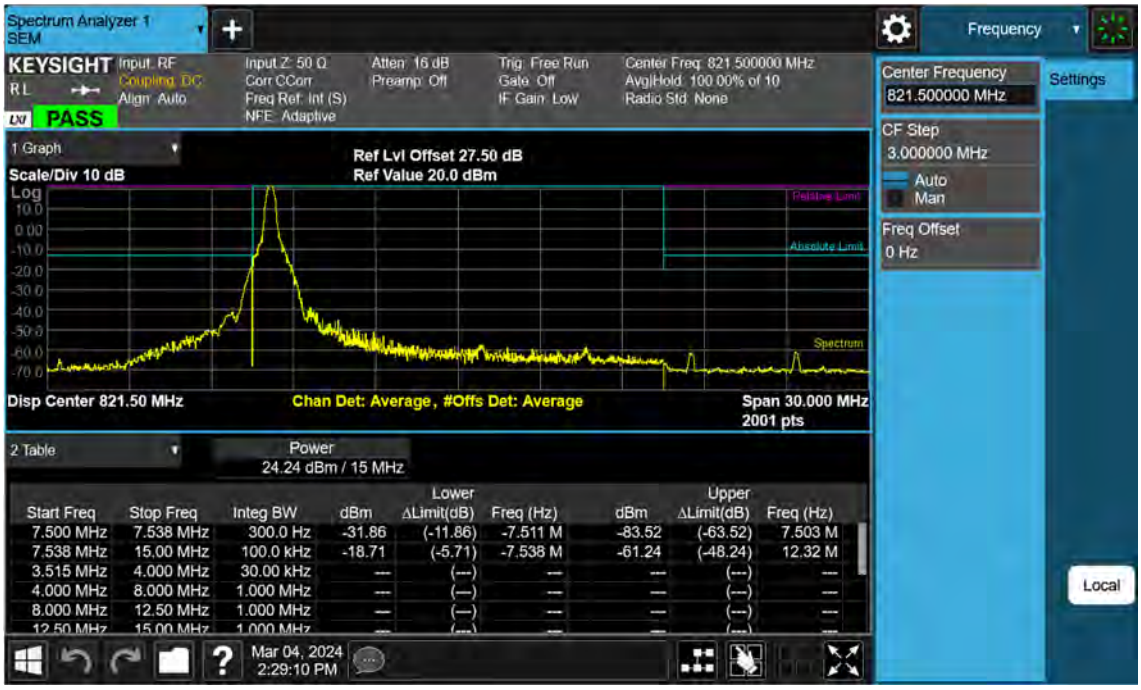


Sub6 n26. Upper Channel Edge Plot (10 M BW Ch.164800 BPSK_RB1_Offset 51)

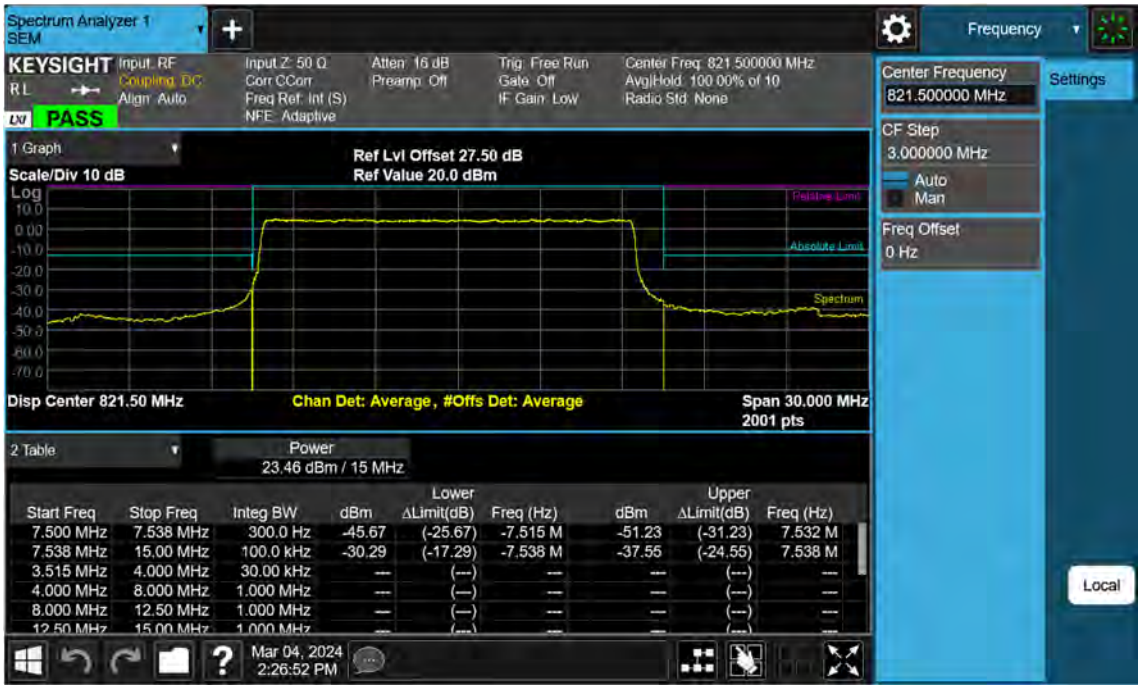


Sub6 n26. Upper Channel Edge Plot (10 M BW Ch.164800 BPSK_RB50_Offset 0)

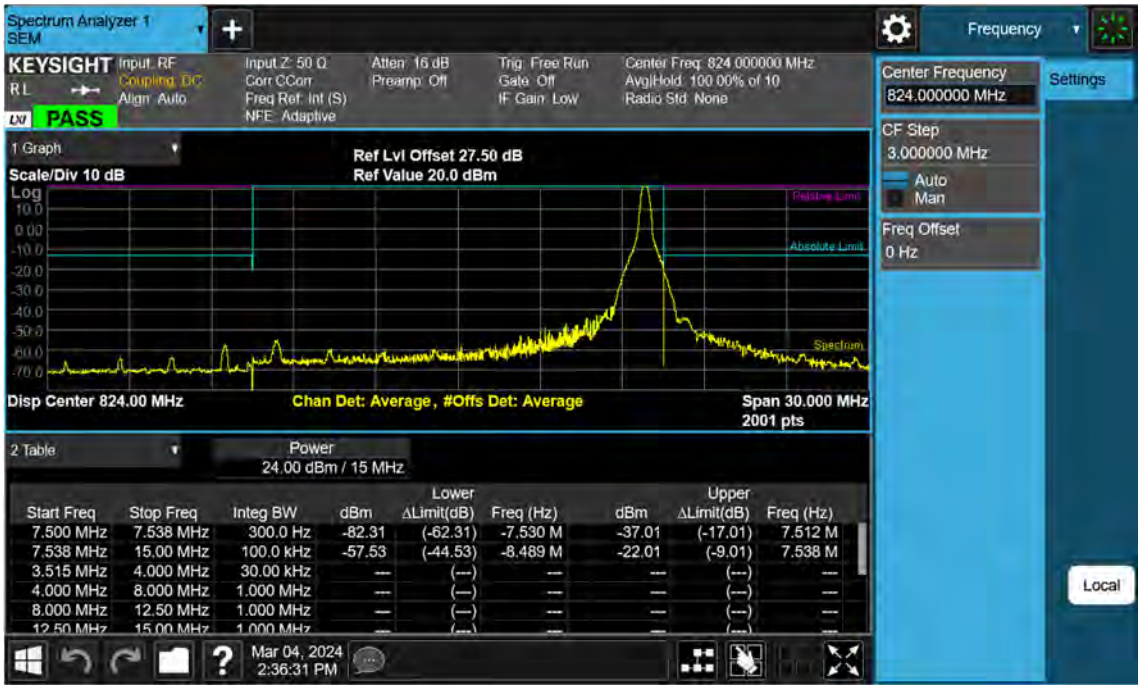
Sub6 n26. Low Channel Edge Plot (15 M BW Ch.164300 BPSK RB 1, Offset 0)



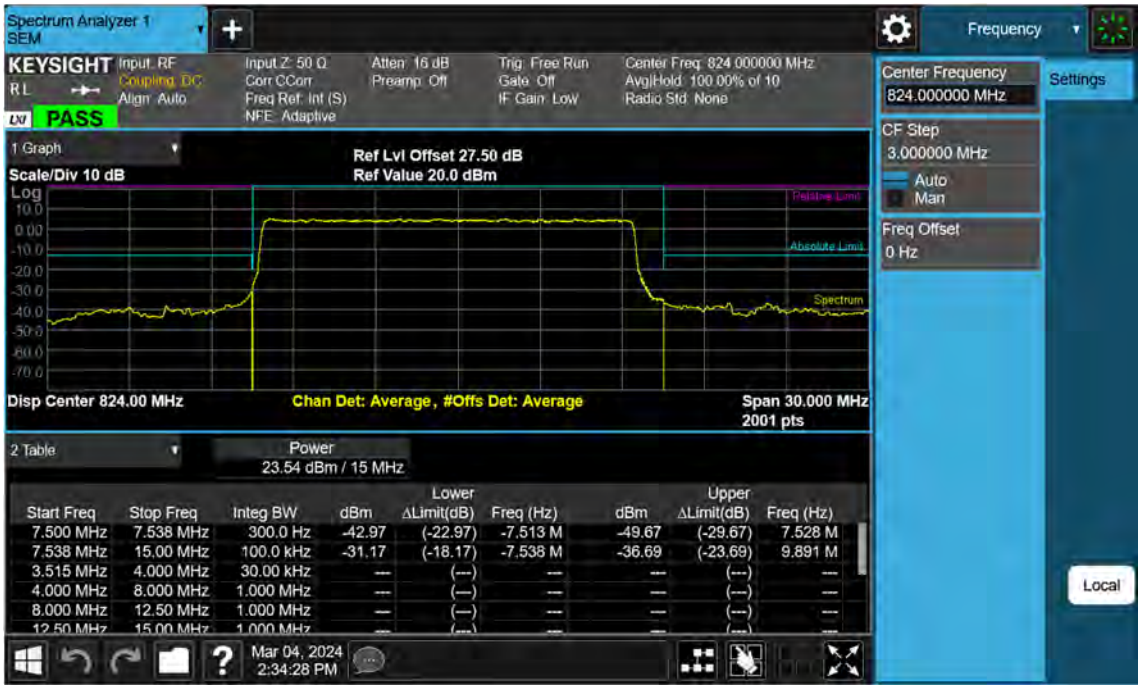
Sub6 n26. Low Channel Edge Plot (15 M BW Ch.164300 BPSK_RB75_Offset 0)



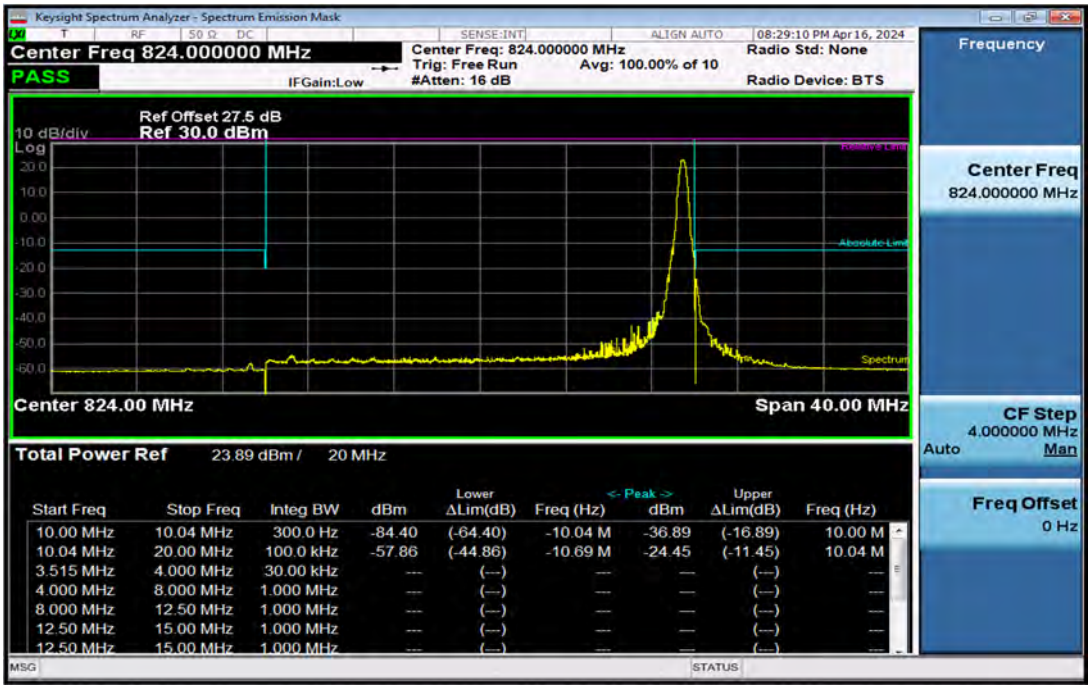
Sub6 n26. Upper Channel Edge Plot (15 M BW Ch.164800 BPSK_RB1_Offset 78)



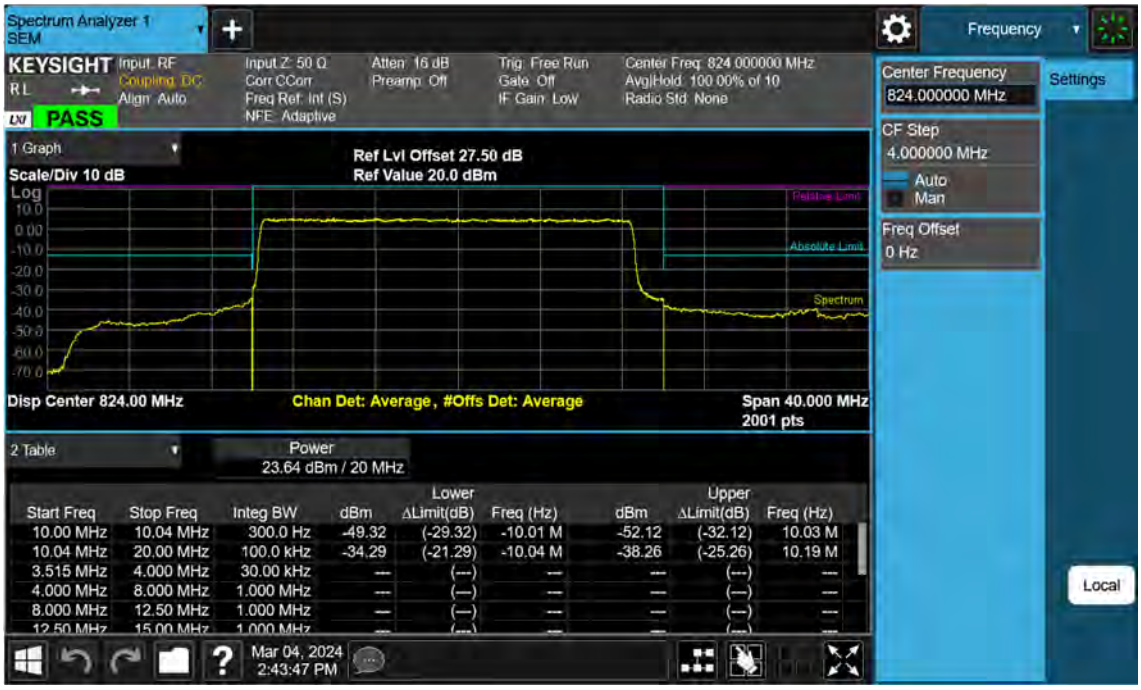
Sub6 n26. Upper Channel Edge Plot (15 M BW Ch.164800 BPSK_RB75_Offset 0)



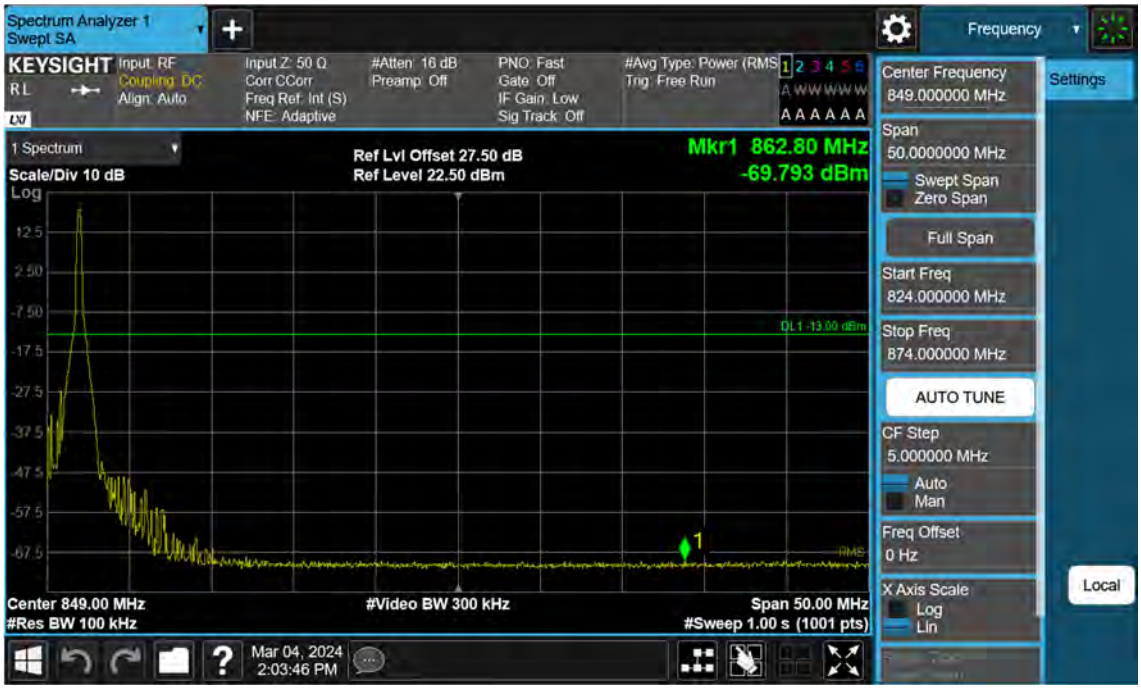
Sub6 n26. Mid Channel Edge Plot (20 M BW Ch.164800 QPSK_ RB1_Offset 105)



Sub6 n26. Mid Channel Edge Plot (20 M BW Ch.164800 BPSK_ RB100_Offset 0)

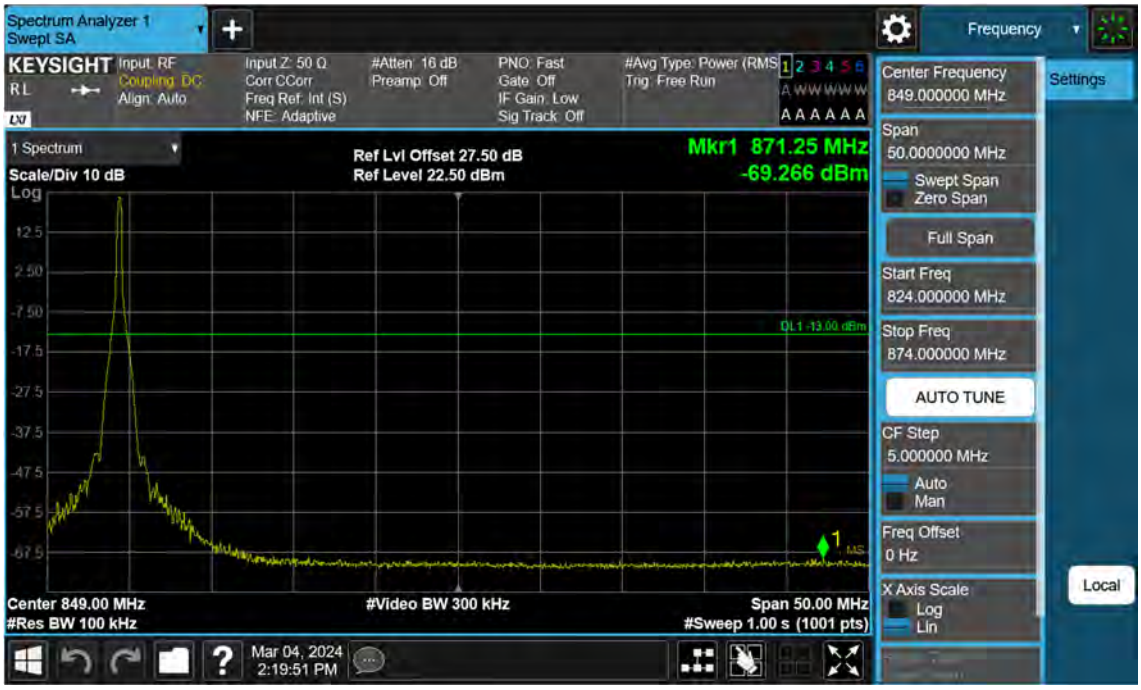


Sub6 n26. Upper Band Edge Plot (5 M BW Ch.164800 BPSK_RB1_Offset 24)



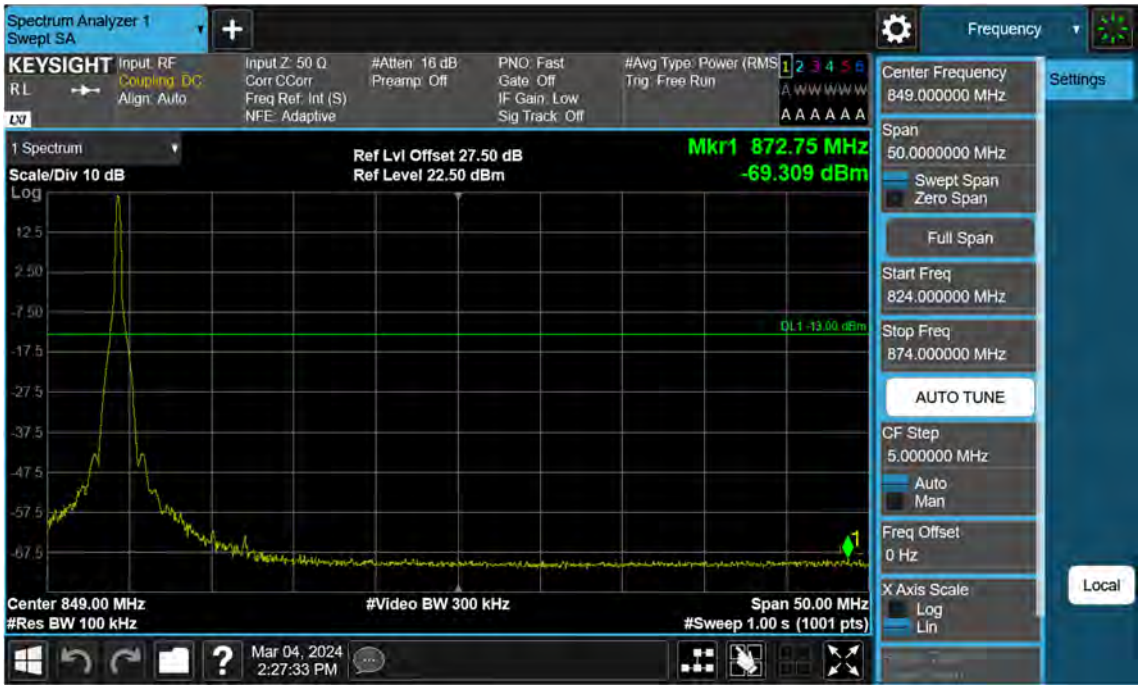
Sub6 n26. Upper Band Edge Plot (5 M BW Ch.164800 BPSK_RB25_Offset 0)

Sub6 n26. Upper Band Edge Plot (10 M BW Ch.164800 BPSK_RB1_Offset 51)



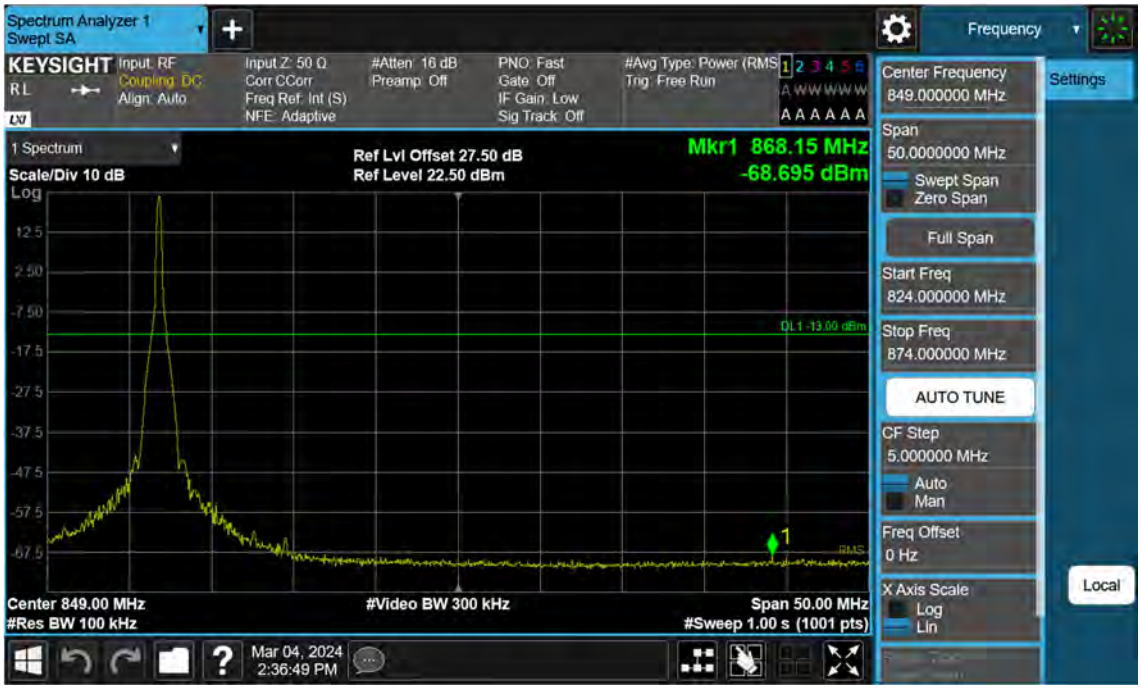
Sub6 n26. Upper Band Edge Plot (10 M BW Ch.164800 BPSK_RB50_Offset 0)

Sub6 n26. Lower Band Edge Plot (15 M BW Ch.164300 BPSK_RB1_Offset 78)



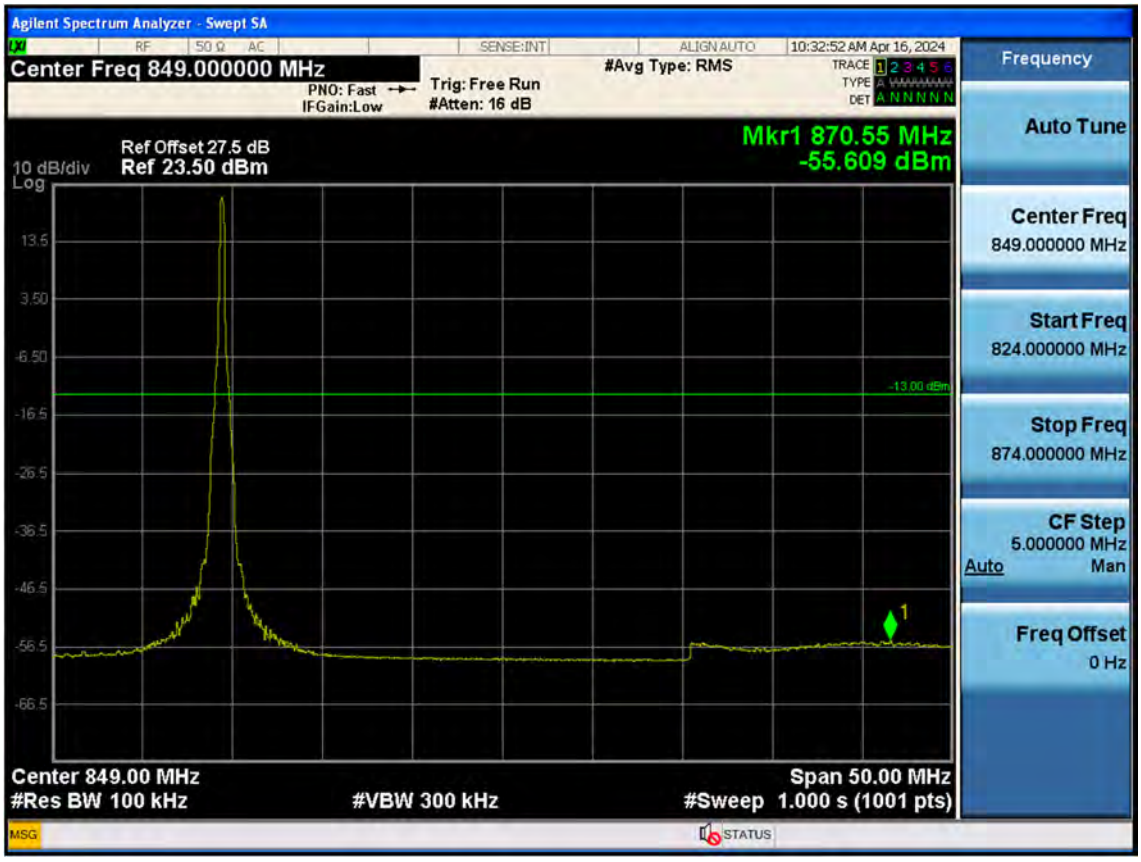
Sub6 n26. Lower Band Edge Plot (15 M BW Ch.164300 BPSK_RB75_Offset 0)

Sub6 n26. Upper Band Edge Plot (15 M BW Ch.164800 BPSK_RB1_Offset 78)



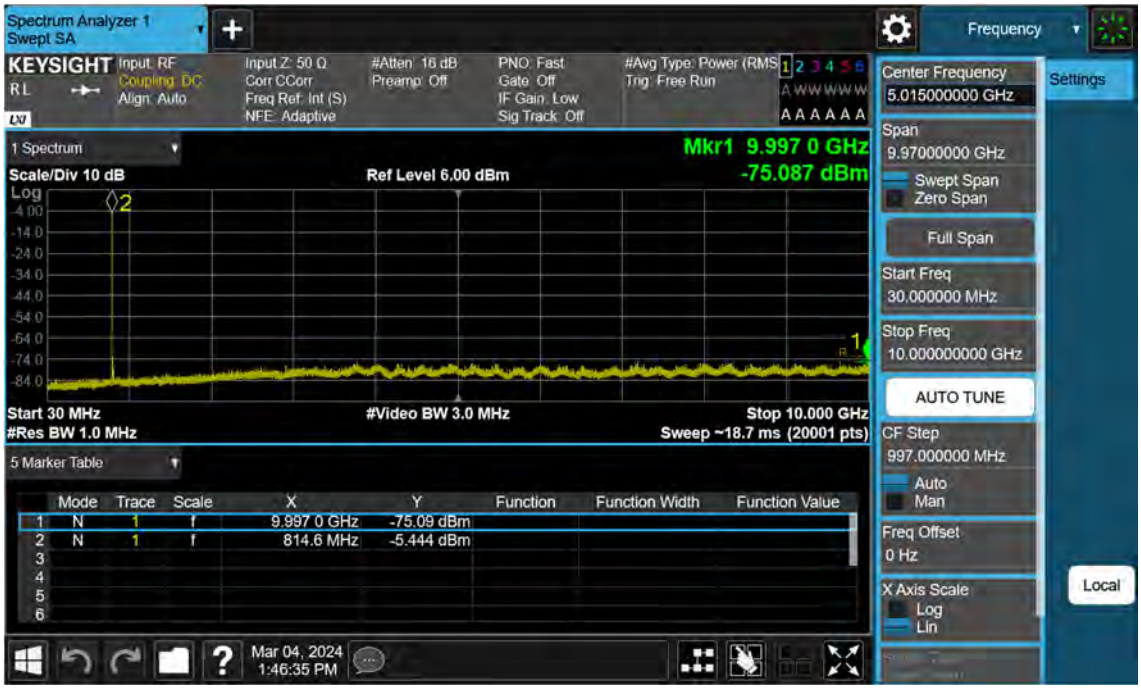
Sub6 n26. Upper Band Edge Plot (15 M BW Ch.164800 BPSK_RB75_Offset 0)

Sub6 n26. Mid Band Edge Plot (20 M BW Ch.164800 BPSK_RB1_Offset 105)

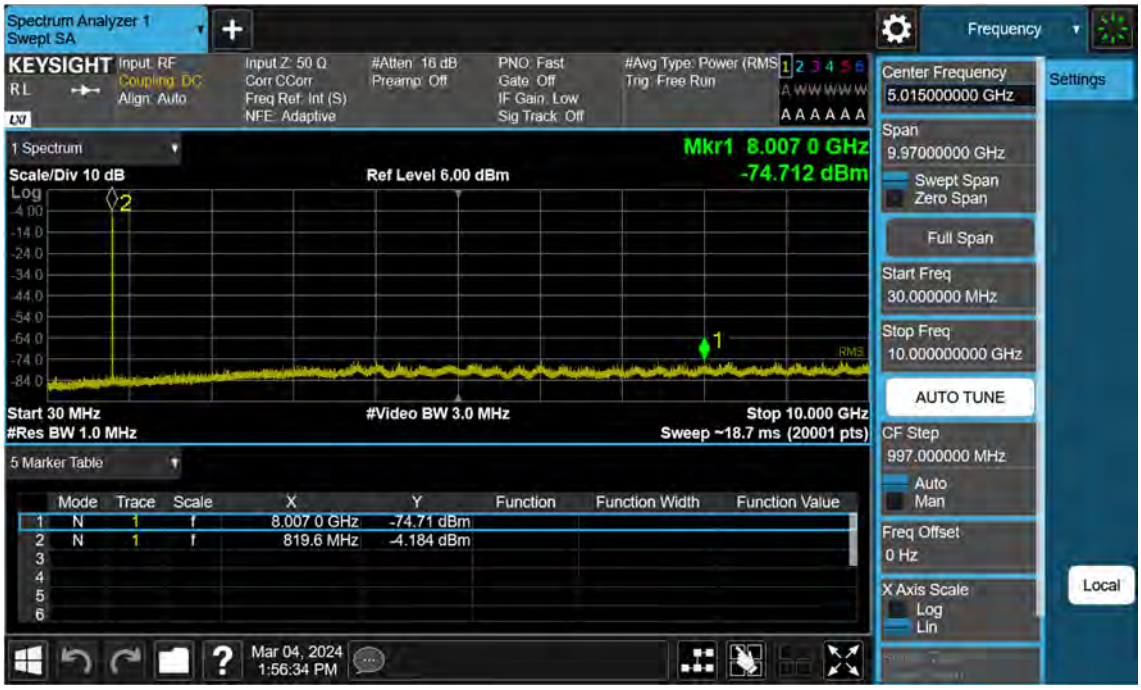


Sub6 n26. Mid Band Edge Plot (20 M BW Ch.164800 BPSK_RB100_Offset 0)

Sub6 n26. Conducted Spurious (163300 ch_5 MHz_ BPSK_RB 1_1)

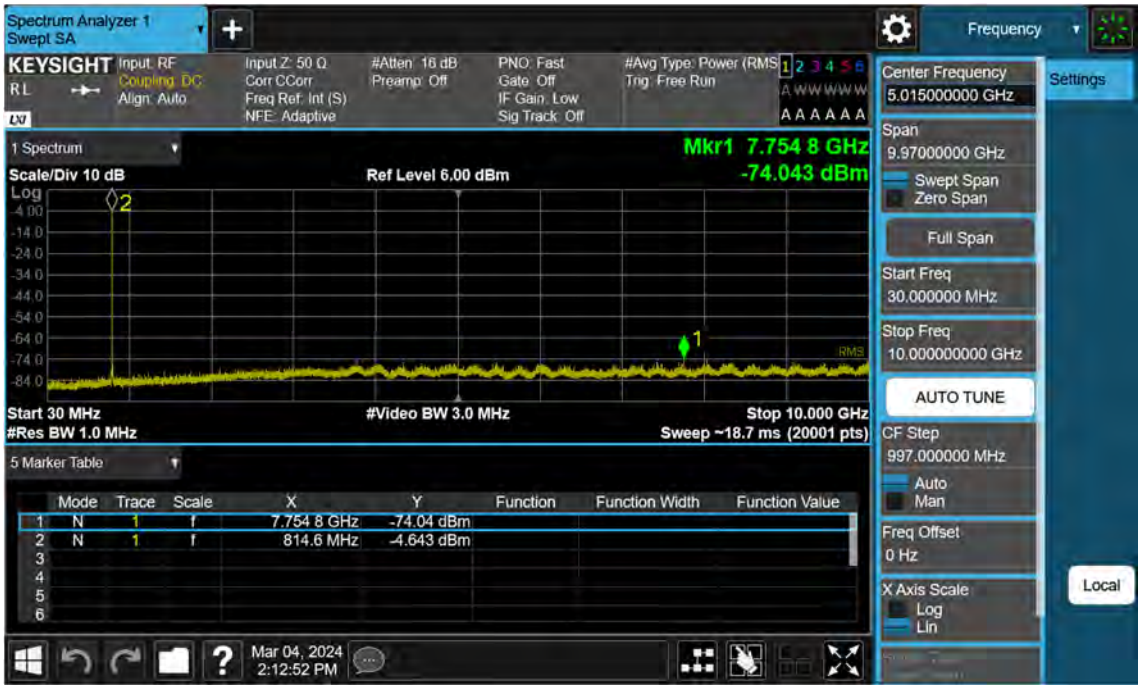


Sub6 n26. Conducted Spurious (164300 ch_5 MHz_ BPSK_RB 1_1)

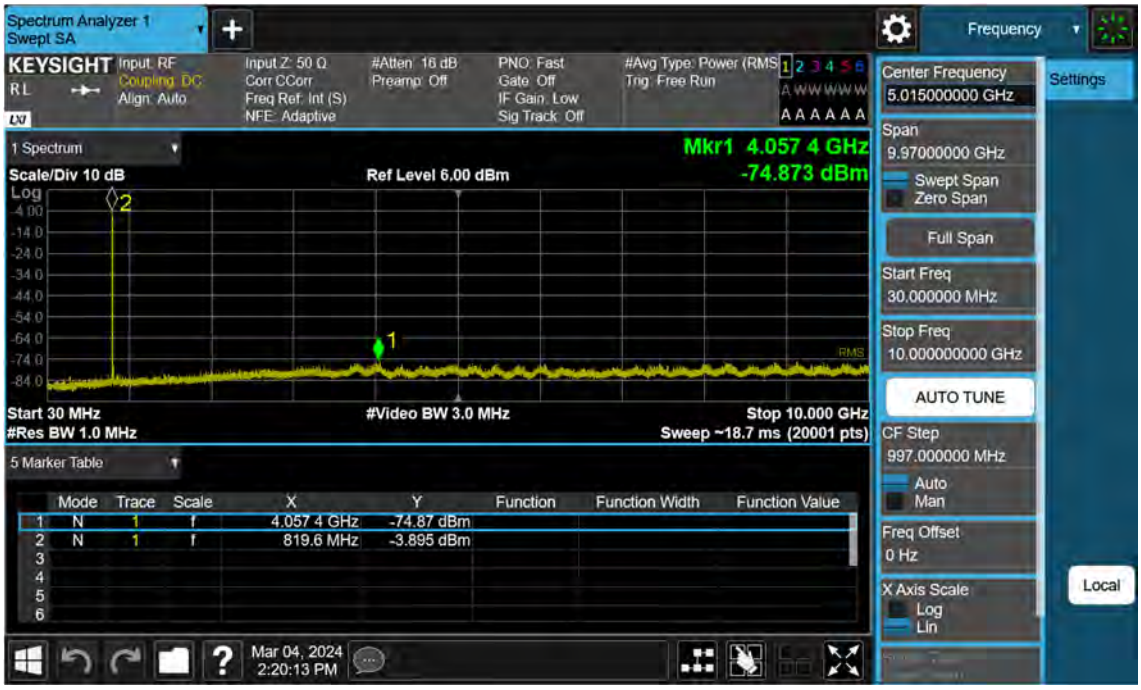


Sub6 n26. Conducted Spurious (164800 ch_5 MHz_ BPSK_RB 1_1)

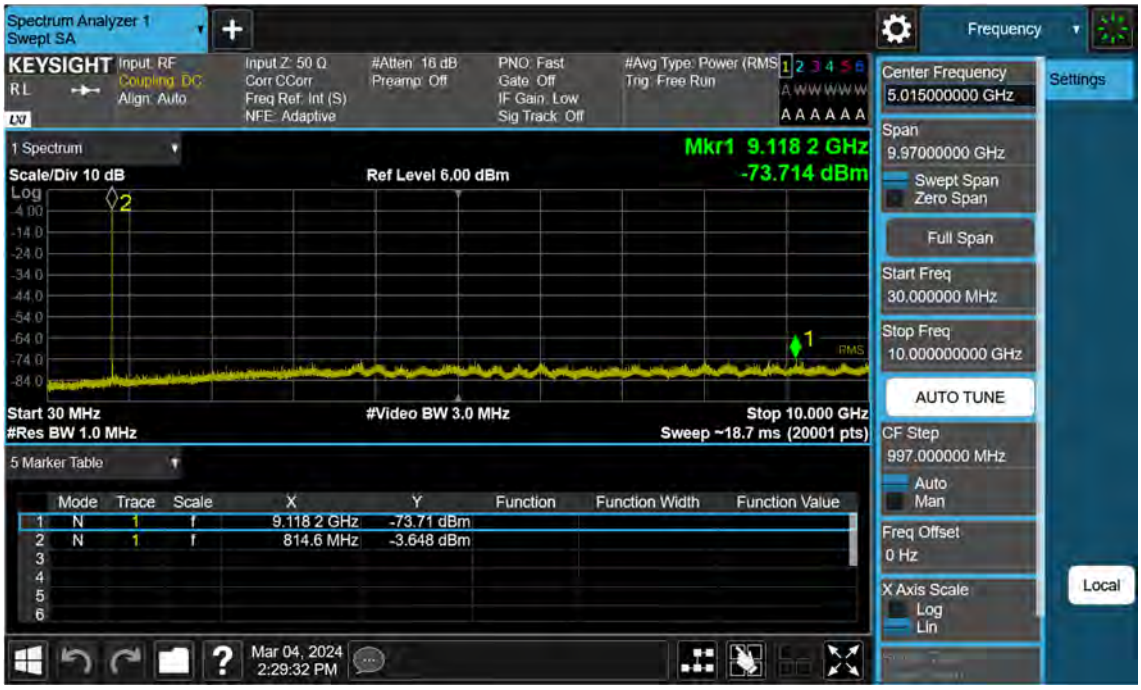
Sub6 n26. Conducted Spurious (163800 ch_10 MHz_ BPSK_RB 1_1)



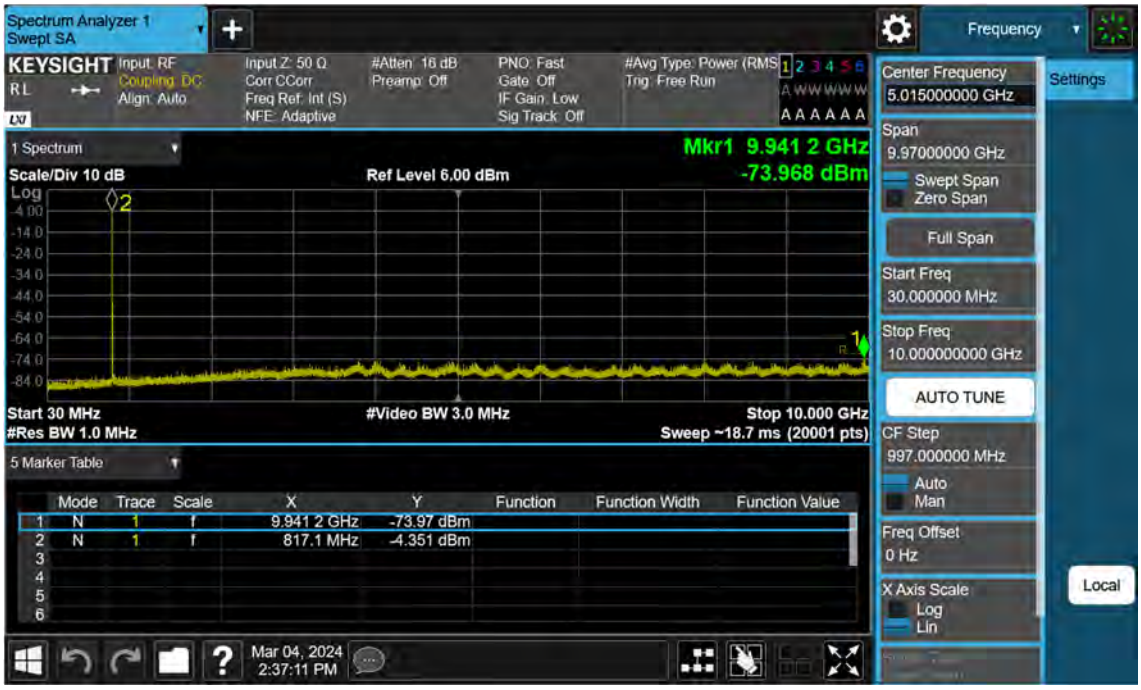
Sub6 n26. Conducted Spurious (164800 ch_10 MHz_ BPSK_RB 1_1)



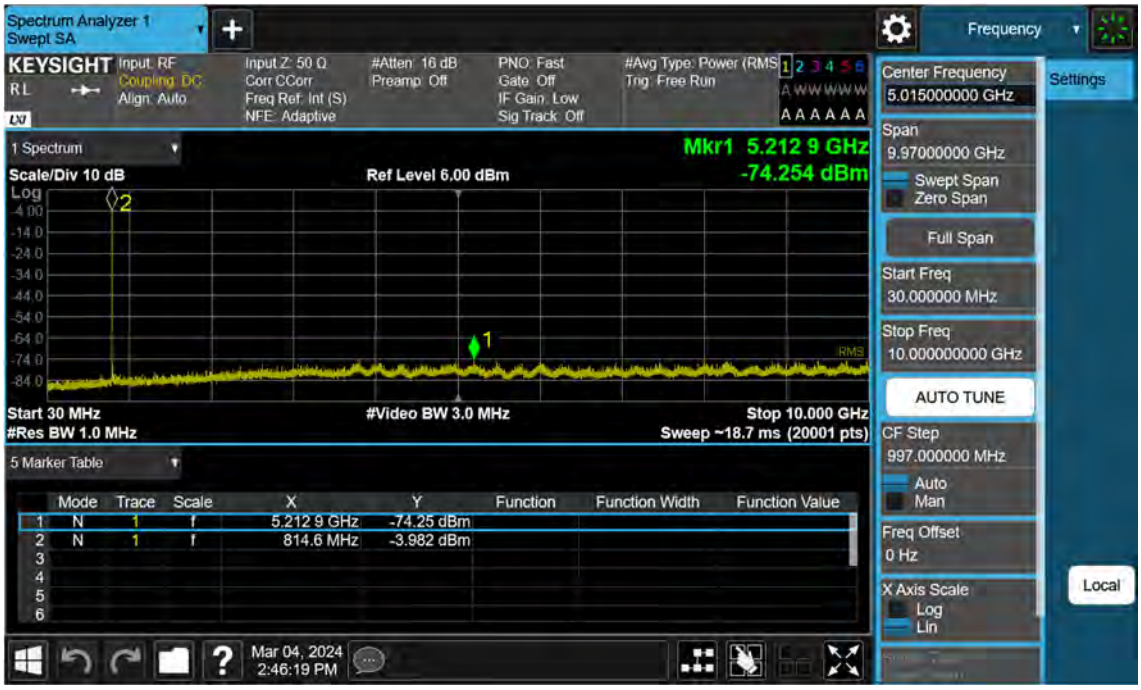
Sub6 n26. Conducted Spurious (164300 ch_15 MHz_ BPSK_RB 1_1)



Sub6 n26. Conducted Spurious (164800 ch_15 MHz_ BPSK_RB 1_1)



Sub6 n26. Conducted Spurious (164800 ch_20 MHz_ BPSK_RB 1_1)



10. ANNEX A_ TEST SETUP PHOTO

Please refer to test setup photo file no. as follows;

No.	Description
1	HCT-RF-2404-FC029-P